

# Colloquium: Physical properties of group-IV monochalcogenide monolayers

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The state-of-the-art knowledge of ferroelectric and ferroelastic group-IV monochalcogenide monolayers is surveyed. These semiconductors feature remarkable structural and mechanical properties, such as a switchable in-plane spontaneous polarization, soft elastic constants, structural degeneracies, and thermally driven two-dimensional structural transformations. Additionally, these 2D materials display selective valley excitations, valley Hall effects, and persistent spin helix behavior. After a description of their Raman spectra, a discussion of optical properties arising from their lack of centrosymmetry (such as an unusually strong second-harmonic intensity, large bulk photovoltaic effects, photostriction, and tunable exciton binding energies) is provided as well. The physical properties observed in these materials originate from (correlate with) their intrinsic and switchable electric polarization, and the physical behavior hereby reviewed could be of use in nonvolatile memory, valleytronic, spintronic, and optoelectronic devices: these 2D multiferroics enrich and diversify the 2D material toolbox.

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## I. INTRODUCTION: THE DIVERSITY OF ULTRATHIN FERROELECTRICS

Ferroelectric materials display a spontaneous, intrinsic polarization **P** that can be switched by external electric fields. The first ferroelectric material, Rochelle salt, was discovered about a century ago (Valasek, 1921). Despite a long history of applications of ferroelectrics in electric and electronic devices,

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TABLE I. Experimentally reported layered ferroelectrics, including the space group of the ferroelectric phase, its intrinsic and switchable polarization [in-plane (IP) and out-of-plane (OOP)], the preparation methods employed, the critical temperature above which a paraelectric phase ensues, the coercive field  $E_c$  (thicknesses for which  $T_c$  and  $E_c$  were determined are added in parenthesis), and other related properties. If the space group was not specified in the source literature, a prefix “d” (for *distorted*) was added in front of the space group of the corresponding undistorted high-symmetry structure. ML stands for monolayer.  $P$  stands for spontaneous polarization.

Material	Space group	<b>P</b> direction	Preparation <sup>a</sup>	$T_c$ (K)	$E_c$ (kV/cm)	Other properties
$\alpha$ -In <sub>2</sub> Se <sub>3</sub>	$R\bar{3}m$	IP + OOP	ME	700 (4 ML)	200 (5 nm)	$d_{33} = 0.34$ pm/V <sup>b</sup> (1 ML)
$\beta'$ -In <sub>2</sub> Se <sub>3</sub>	$d\text{-}R\bar{3}m$	IP	ME	> 473 (100 nm)		
CuInP <sub>2</sub> S <sub>6</sub>	$Cc$	IP + OOP <sup>c</sup>	ME	> 320 (4 nm)		
BA <sub>2</sub> PbCl <sub>4</sub>	$Cmc2_1$	IP	ME	> 300 (2 ML)	13 (bulk)	$P \sim 13$ $\mu$ C/cm <sup>2</sup>
d1T'-MoTe <sub>2</sub>	$d\text{-}P\bar{3}m$	OOP	ME, MBE	330 (1 ML)		
1T'-WTe <sub>2</sub>	$Pnm2_1$	OOP	ME	350 (2 to 3 ML)		$P \neq 0$ only when $\geq 2$ ML
SnS odd-ML	$P2_1mn$	IP	MBE, PVD	> 300 (1–15 ML)	10.7/25 (1/9 ML)	
SnSe ML	$P2_1mn$	IP	MBE	380–400 (1 ML)	140 (1 ML)	
SnTe ML	$P2_1mn$	IP	MBE	270 (1 ML)		

<sup>a</sup>MBE, molecular beam epitaxy; ME, mechanical exfoliation; PVD, physical vapor deposition.

<sup>b</sup>Piezoelectric coefficient.

<sup>c</sup>Vanishing in-plane polarization below a critical thickness of 90–100 nm.

the modern theory of ferroelectricity based on the Berry phase (which made accurate comparisons between theory and experimental measurements possible) was not established until the 1990s (King-Smith and Vanderbilt, 1993; Resta, 1994); see Rabe, Ahn, and Triscone (2007) for more details. From that point on, deep connections of this field with the geometry and topology of quantum mechanical wave functions have been pointed out (Bernevig and Hughes, 2013; Vanderbilt, 2018). Ferroelectric behavior is relevant from both a fundamental physical perspective and applications, and this Colloquium was written to highlight the physical properties of 2D ferroelectric and ferroelastic materials within the group-IV monochalcogenide family (Littlewood, 1980).

Researchers have always wondered whether there is a critical thickness for ferroelectric behavior below which polarization switching becomes suppressed (Rabe, Ahn, and Triscone, 2007). Concerning nonlayered ferroelectric films with an out-of-plane intrinsic polarization **P**, it was initially thought that the depolarization field arising from an incomplete cancellation of the space charge and an out-of-plane polarization charge at an electrode-ferroelectric interface [see, Merz (1956), Janovec (1959), Triebwasser (1960), Mehta, Silverman, and Jacobs (1973), and Black, Farrell, and Licata (1997)] would raise the total energy of the system and eventually suppress the polarized state. Nevertheless, and as growth techniques for thin films developed, the experimentally extracted critical thickness of ferroelectric thin films decreased from over 100 nm (Feuersanger, Hagenlocher, and Solomon, 1964) to tens of nanometers (Slack and Burfoot, 1971; Tomashpolski, 1974; Tomashpolski *et al.*, 1974), and eventually to only a few unit cells (u.c.'s) (Bune *et al.*, 1998; Tybell, Ahn, and Triscone, 1999). The behavior of ultrathin ferroelectric films has been predicted to high precision by first-principles calculations, suggesting critical thicknesses of several u.c.'s for certain materials (Meyer and Vanderbilt, 2001; Zembilgotov *et al.*, 2002; Junquera and Ghosez, 2003; Wu *et al.*, 2004; Sai, Kolpak, and Rappe, 2005; Gerra *et al.*, 2006), and single-u.c. thickness for others (Almahmoud *et al.*, 2004; Sai, Fennie, and Demkov, 2009; Almahmoud, Kornev, and Bellaiche, 2010; Zhang *et al.*, 2014). Concurrently, sophisticated experiments on select compounds [PbTiO<sub>3</sub>

(3 u.c.'s) (Fong *et al.*, 2004, 2006), BaTiO<sub>3</sub> (4 u.c.'s) (Tenne *et al.*, 2006, 2009), PbZr<sub>0.2</sub>Ti<sub>0.8</sub>O<sub>3</sub> (1.5 u.c.'s) (Gao *et al.*, 2017), YMnO<sub>3</sub> (2 u.c.'s) (Nordlander *et al.*, 2019), and BiFeO<sub>3</sub> (1 u.c.) (Wang *et al.*, 2018)] continue to push the critical thickness toward the single-u.c. limit.

Meanwhile, a series of ultrathin *layered* ferroelectric materials (especially attractive for the design and fabrication of functional van der Waals heterostructures) have been experimentally discovered, including In<sub>2</sub>Se<sub>3</sub> (Ding *et al.*, 2017; Zhou *et al.*, 2017; Cui *et al.*, 2018; Poh *et al.*, 2018; Wan *et al.*, 2018; Xiao *et al.*, 2018; Xue *et al.*, 2018a, 2018b; Zheng *et al.*, 2018), CuInP<sub>2</sub>S<sub>6</sub> (Liu *et al.*, 2016; Deng *et al.*, 2020), BA<sub>2</sub>PbCl<sub>4</sub> (Liao *et al.*, 2015; You *et al.*, 2018), distorted 1T- (d1T-) MoTe<sub>2</sub> (Yuan *et al.*, 2019), 1T-WTe<sub>2</sub> (Fei *et al.*, 2018) [which is also a quantum spin Hall material (Qian *et al.*, 2014; Fei *et al.*, 2017; Tang *et al.*, 2017; Asaba *et al.*, 2018; Song *et al.*, 2018; Wu *et al.*, 2018)], and monolayers (MLs) of group-IV monochalcogenides like SnS, SnSe, and SnTe. An experimentally driven summary of layered ferroelectrics is provided in Table I.

The discovery of 2D and layered ferroelectrics facilitates the design of future nonvolatile devices that are fully made of 2D material heterostructures. The experimentally verified 2D ferroelectric materials exhibit both out-of-plane and in-plane switchable spontaneous polarizations in few-layer films and at room temperature. Some prototype devices have also been demonstrated. For example, a ferroelectric diode in a graphene/ $\alpha$ -In<sub>2</sub>Se<sub>3</sub> heterostructure has a relatively low coercive field of 200 kV/cm, and an electric current on-off ratio of  $\sim 10^5$  (Wan *et al.*, 2018). A d1T'-MoTe<sub>2</sub> ferroelectric tunneling junction yielded an electric current on-off ratio of 1000 (Yuan *et al.*, 2019).

Among all ultrathin ferroelectrics, a family of ferroelectric semiconductors with moderate band gaps known as group-IV monochalcogenide MLs (and referred to as *MX* MLs henceforth) exhibit outstanding properties that are promising for many applications. They are the only family of 2D ferroelectrics experimentally shown to display a robust and switchable in-plane spontaneous polarization at the limit of a single van der Waals ML at room temperature. Furthermore, many intriguing physical behaviors have been theoretically

predicted in  $MX$  MLs such as selective valley excitations, valley Hall effects, persistent spin helix behavior, etc.

Nevertheless, and despite of these attractive theoretical predictions, the experimental growth and characterization remains difficult, partly because of reduced sample dimensions. Therefore, reviewing the current achievements and spurring a broader interest in this field provided the motivation to write this Colloquium. Despite the existence of several reviews focusing on the computational (Cui, Xue *et al.*, 2018; Wu and Jena, 2018), experimental-computational (Guan *et al.*, 2020), and experimental-theoretical (Titova, Fregoso, and Grimm, 2020) aspects of 2D ferroelectrics, an all-encompassing review dedicated to the physical behavior of  $MX$  MLs is still missing.

The structure of this Colloquium is as follows. The atomistic structure of  $MX$ 's in the bulk and MLs is discussed in Sec. II. Atomistic coordination, the nature of their chemical bond, group symmetries, order parameters, and unexpected atomistic configurations experimentally obtained are covered in that section. Section III introduces the three members of this family (SnS, SnSe, and SnTe) that have been grown at the ML limit. Experimental characterization, including the verification of polarization at exposed edges in ML nanoplates, can be found there as well. The experimental ferroelectric switching of SnS, SnSe, and SnTe MLs is discussed in Sec. IV; novel memory concepts based on an in-plane ferroelectric switching are also introduced in that section.

Linear elastic properties, structural degeneracies, and finite temperature thermal behavior (including phase transitions) are covered in Secs. V–VII, respectively. In a nutshell,  $MX$  MLs are much softer than graphene, hexagonal boron nitride MLs, and transition metal dichalcogenide (TMDC) MLs. Their linear elastic properties, unusually large piezoelectric coefficients, and auxetic behavior are described in Sec. V. In Sec. VI the elastic energy landscape is introduced, which permits one to understand the structural degeneracies of these 2D ferroelectrics and the structural phase transitions that are discussed in Sec. VII.

Electronic and optical properties of  $MX$  MLs are the subjects of Secs. VIII and IX. The electronic properties are discussed in a gradual manner that includes band structures and valley properties without spin-orbit coupling, and a subsequent exposition of spin-enabled persistent spin helix behavior. Optical properties include the anisotropic absorption spectra, Raman spectra, second-harmonic generation (SHG), injection and shift currents, photostriction, and excitonic effects. A summary and outlook is presented in Sec. X.

A unified and consistent notation has been deployed to streamline the discussion. In particular, the choice of crystallographic axes is such that orthogonal lattice vectors  $\mathbf{a}_{1,0}$ ,  $\mathbf{a}_{2,0}$ , and  $\mathbf{a}_{3,0}$  correspond to crystallographic vectors  $\mathbf{a}$ ,  $\mathbf{b}$ , and  $\mathbf{c}$  and point along the  $x$ ,  $y$ , and  $z$  directions, respectively [ $\mathbf{a}_1$  ( $\mathbf{a}_2$ ) is the so-called armchair (zigzag) direction]. These choices will lead to a modification of space group labeling, a redefinition of high-symmetry points in the electronic band structure, and the relabeling of tensors from some of the source literature. The benefit from this effort is a self-contained discussion that is not interrupted from a lack of a standard notation. In addition, given that the structure of these materials evolves as a function of mechanical strain, temperature, electric field, and

optical illumination, structural variables with a zero subindex represent their value on a ground state configuration at zero temperature and without external perturbations.

## II. ATOMISTIC STRUCTURE AND CHEMICAL BONDING OF O- $MX$ 'S FROM THE BULK TO MLs

Group-IV monochalcogenides are binary compounds with a chemical formula  $MX$ , where  $M$  is a group-IVA element and  $X$  belongs to group VIA in the periodic table. Even though carbon, silicon, lead, oxygen, and even polonium belong to these groups,  $MX$  compounds containing these elements are not discussed here for the following reasons: SiS MLs possess a ground state structure with  $Pma2$  symmetry (Yang *et al.*, 2016), which lacks a net intrinsic electric polarization; see Kamal, Chakrabarti, and Ezawa (2016), which addressed a lower-energy structure for 2D SiSe too. PbX compounds lack a net  $\mathbf{P}$  regardless of the number of layers (more on this later). Similarly, materials such as 2D SiO, GeO, and SnO display a nonferroelectric litharge structure (Lefebvre *et al.*, 1998; Kamal, Chakrabarti, and Ezawa, 2016). This way,  $M$  will be either germanium (Ge) or tin (Sn), while  $X$  represents sulfur (S), selenium (Se), or tellurium (Te) in what follows.

GeTe and SnTe are rhombohedral ( $R$  phase) and GeS, GeSe, SnS, and SnSe turn orthorhombic ( $O$  phase) in the bulk (Littlewood, 1980). As illustrated in Fig. 1(a), O- $MX$  compounds have a layered structure. One ML refers to a van der Waals layer (or two atomic layers) or half of an O- $MX$  u.c.

Strictly speaking, the intrinsic switchable polarization  $\mathbf{P}$  should not be showcased as a vector on periodic structures. Therefore, in certain theoretical discussions we will utilize an order parameter  $\mathbf{p}_0$  (parallel to  $\mathbf{P}$ ) that remains well defined on periodic structures. The letter  $p$  stands for *projection*, and this order parameter is defined next.

Consider the vector  $\mathbf{r}_{XM}$  starting at  $X$  atom 1 and ending at the nearest  $M$  atom (atom 2) in the lower ML seen in Fig. 1(a). The positions of the remaining two atoms within the lower ML (3 and 4) are obtained by a screw operation about the  $x$  axis, or by a diagonal ( $n$ ) glide operation about the  $z$  axis applied to  $\mathbf{r}_{XM}$ . Calling  $\mathbf{r}_{X'M}$  the vector starting at ( $X$ ) atom 3 and ending at ( $M$ ) atom 4, we define  $\mathbf{p}_0 = \mathbf{r}_{XM} + \mathbf{r}_{X'M}$ . The mirror symmetry along the  $x$ - $z$  plane makes  $\mathbf{p}_0 \cdot \hat{y} = 0$ , while the screw operation renders  $\mathbf{p}_0 \cdot \hat{z} = 0$  so that  $\mathbf{p}_0$  is parallel to the longer lattice vector  $\mathbf{a}_{1,0}$ . These symmetries also render a zero intrinsic polarization along the  $y$  and  $z$  directions. Ferroelectric O- $MX$  MLs belong to space group 31 (Kamal, Chakrabarti, and Ezawa, 2016; Rodin *et al.*, 2016) [usually written as  $Pnm2_1$  but labeled  $P2_1mn$  for lattice vectors as drawn in Fig. 1(c)], and a top view of their anisotropic u.c. is provided in Fig. 1(c) with solid lines. Phonon dispersion calculations demonstrate the structural stability of these MLs (Singh and Hennig, 2014). A zero value of the order parameter  $\theta$  in a ML with dissimilar lattice constants ( $a_{1,0} \neq a_{2,0}$ ) leads onto a paraelectric structure with  $\mathbf{p} = \mathbf{0}$  belonging to symmetry group 59 ( $Pmmn$ ).

The alternating direction of  $\mathbf{p}_0$  (or antipolar coupling) among individual MLs arises from the inversion center shown in the side view along the  $x$ - $z$  plane in Fig. 1(a) (the atoms related by inversion are joined by dash-dotted lines). Bulk O- $MX$ 's belong to space group 62 [ $Pnma$  (Gomes and



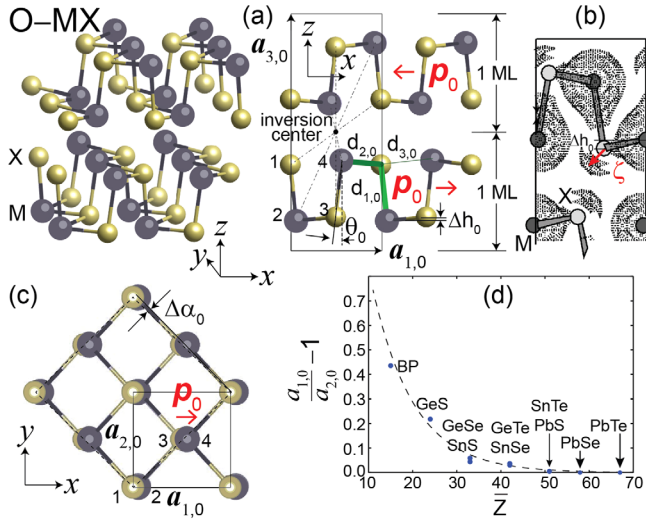


FIG. 1. (a) Structure of bulk O-MX's, with the  $M$  atom shown in dark gray (large circles) and the  $X$  atom in yellow (light gray, small circles). Left panel: 3D view of two MLs with antiparallel polarization. Right panel: side view along the  $x$ - $z$  plane showing  $a_{1,0}$  and  $a_{3,0}$  lattice vectors ( $a_{2,0}$  points into the page). The inversion center swaps the direction of  $\mathbf{p}_0$  at consecutive MLs (red arrows), and  $p_0 = |\mathbf{p}_0| \propto \theta_0$ . Interatomic distances  $d_{1,0}$ ,  $d_{2,0}$ , and  $d_{3,0}$  as well as  $\Delta h_0$  are shown too. (b) Electronic density showing a lone pair  $\zeta$  and  $\Delta h_0$ . Dark (light) circles stand for germanium or tin (sulfur or selenium). Adapted from Lefebvre *et al.*, 1998. (c) Top view of an O-MX ML.  $\Delta\alpha$  measures the deviation from  $90^\circ$  of the rhombus highlighted by dashed lines;  $\Delta\alpha_0 = 0$  when  $a_{1,0} = a_{2,0}$ . (d) The  $a_{1,0}/a_{2,0}$  ratio (proportional to  $\Delta\alpha_0$ ) is tunable by the compound's average atomic number  $\bar{Z}$ . Adapted from Mehboudi, Dorio *et al.*, 2016.

Carvalho, 2015), or  $Pcmn$  with the lattice vectors employed here]. The side view of the  $x$ - $z$  plane in Fig. 1(a) also contains the u.c. boundaries in solid line, interatomic distances  $d_{1,0} < d_{2,0} < d_{3,0}$ , a tilt angle  $\theta_0$ , and the height  $\Delta h_0$  of an  $X$  atom relative to its nearest  $M$  atom (Kamal, Chakrabarti, and Ezawa, 2016). A net switchable  $\mathbf{P}_0$  ensues in binary compounds lacking inversion symmetry, which is the case for individual MLs of O-MX's (Tritsaris, Malone, and Kaxiras, 2013; Singh and Hennig, 2014; Fei *et al.*, 2015; Gomes and Carvalho, 2015; Gomes, Carvalho, and Castro Neto, 2015; Zhu *et al.*, 2015). The atomistic structure and the in-plane  $\mathbf{p}_0$  of O-MX MLs can be understood on the basis of the chemistry of black phosphorus (BP) MLs as follows.

Carbon belongs to group IVA and graphite has four valence electrons and an  $sp^2$  hybridization. Phosphorus belongs to group VA, and black phosphorus has five valence electrons and displays an  $sp^3$  hybridization (Kamal, Chakrabarti, and Ezawa, 2016). In threefold coordinated graphite, three atoms form strong ( $\sigma$ ) in-plane bonds and the fourth ( $\pi$ ) electron protrudes out of plane. BP is threefold coordinated as well, having its closest neighboring atom at a distance  $d_1$  and two additional atoms located at a slightly larger distance  $d_2$ . Given that a phosphorus atom contains five valence electrons, such threefold coordination requires the existence of two additional nonbonded electrons [known as a *lone pair* ( $\zeta$ )] per atom. Unlike graphene, which maintains a planar configuration with two atoms in its

TABLE II. Interatomic distances in bulk SnS and SnSe.  $N$  is the number of neighbors at any given distance. From Lefebvre *et al.*, 1998.

Material	Atoms	$d$ (Å)	$N$
SnS	Sn-S	2.63 ( $d_{1,0}$ )	1
		2.66 ( $d_{2,0}$ )	2
		3.29 ( $d_{3,0}$ )	2
	Sn-Sn	3.39	1
		3.49	2
		3.71	4
SnSe	Sn-Se	3.90	2
		2.74 ( $d_{1,0}$ )	1
		2.79 ( $d_{2,0}$ )	2
	Sn-Sn	3.34 ( $d_{3,0}$ )	2
		3.47	1
		3.55	2
	Se-Se	3.89	4
		3.94	2

u.c., lone pairs confer BP MLs with a puckered structure and a rectangular u.c. containing four atoms.

As in the case of hexagonal boron nitride [which is made out of a group-III element (B) and a group-VA element (N) and is isostructural to graphite], Fig. 1(a) indicates that O-MX's are isostructural to BP. Table II shows that bulk SnS has similar distances  $d_1$  and  $d_2$  for a threefold atomistic coordination, and the same can be said of interatomic distances in bulk SnSe, which is also listed in the table. The equivalent to a lone pair  $\zeta$  is assigned to the more negatively charged  $X$  atom in Fig. 1(b) (Lefebvre *et al.*, 1998). Notice that  $\Delta h_0$  is positive in Fig. 1(a) and negative in Fig. 1(b): its sign determines certain elastic properties that are discussed in Sec. V.

The rhombic distortion angle  $\Delta\alpha_0$  (Chang *et al.*, 2016) shown in Fig. 1(c) indicates the anisotropy of the u.c. and is related to the ratio of lattice constants  $a_{1,0}/a_{2,0}$  as follows (Barraza-Lopez *et al.*, 2018):

$$\frac{a_{1,0}}{a_{2,0}} = \frac{1 + \sin \Delta\alpha_0}{\cos \Delta\alpha_0}, \quad (1)$$

or  $\Delta\alpha_0 \simeq a_{1,0}/a_{2,0} - 1$  for small angles when  $\Delta\alpha_0$  is expressed in radians.

Letting  $Z_M$  ( $Z_X$ ) be the atomic number of atom  $M$  ( $X$ ) and defining the average atomic number  $\bar{Z} = (Z_M + Z_X)/2$ , we illustrate in Fig. 1(d) a decaying exponential dependence of  $a_{1,0}/a_{2,0} - 1$  on  $\bar{Z}$  (Mehboudi, Dorio *et al.*, 2016).  $a_{1,0}/a_{2,0} - 1$  has been called the *reversible strain* (Wu and Zeng, 2016) or *tetragonality ratio*, and it correlates with  $P_0$  (Lichtensteiger *et al.*, 2005). Figure 1(d) indicates that (at zero temperature) lattice parameters  $a_{1,0}$  and  $a_{2,0}$  become more equal (unequal) on heavier (lighter) MX MLs. Having equal lattice parameters, Fig. 1(d) shows that Pb-based MX MLs are paraelectric [ $P_0 = 0$ , a behavior experimentally confirmed with PbTe MLs; see the Supplemental Material given by Chang *et al.* (2016)] and are not discussed here for that reason. Ferroelectric O-MX MLs with  $a_{1,0} \neq a_{2,0}$  have similar structures and hence display similar physical behavior; this observation will permit one to draw meaningful comparisons



TABLE III. Net charge transfer  $\Delta Q$  (in  $e$ ) from atom  $M$  to atom  $X$  and change in electronegativity  $\Delta\xi = \xi_X - \xi_M$  (in eV) for O- $MX$  MLs. From Kamal, Chakrabarti, and Ezawa, 2016.

Material	$\bar{Z}$	$\Delta Q$	$\Delta\xi$
GeS ML	24	0.815	0.57
GeSe ML	33	0.649	0.54
GeTe ML	42	0.372	0.09
SnS ML	33	0.980	0.62
SnSe ML	42	0.855	0.59
SnTe ML	51	0.596	0.14

between different experimental and theoretically studied compounds within this material family.

Continuing the discussion of chemistry, one observes in Table III a correlation between the charge transfer  $\Delta Q$  [or ionicity (Littlewood, 1980)] from the group-IVA element onto the one belonging to group VIA and Pauling's difference in electronegativity  $\Delta\xi$ . Although an interplay among covalent, ionic, and resonant bonding has been argued to describe  $MX$ 's, a new type of bonding (called *metavalent* and thought of as a combination of “metallic” and “covalent”) has been proposed to classify these materials (Raty *et al.*, 2019; Kooi and Wuttig, 2020; Ronneberger *et al.*, 2020). Variables employed to identify the appropriate type of bonding include the coordination number, the electronic conductivity, the dielectric constant  $\epsilon_\infty$ , the bond polarizability, and the lattice anharmonicity. Setting up a two-dimensional map where the horizontal axis is the charge transfer  $\Delta Q$  and the vertical axis (named *electron sharing*) is a measure of electronic exchange and correlation (Raty *et al.*, 2019), metavalent compounds sit between covalently bonded and metallic materials. In the bulk, materials such as GeS, GeSe, SnS, and SnSe are assigned a covalent bonding, while GeTe can display either covalent or metavalent bonding depending on its phase ( $R$  and cubic phases being metavalent and the  $O$  phase being covalent); bulk SnTe, PbS, PbSe, and PbTe are assigned a metavalent character (Raty *et al.*, 2019; Kooi and Wuttig, 2020).

The in-plane u.c. area (i.e.,  $|\mathbf{a}_{1,0} \times \mathbf{a}_{2,0}|$ ) of O- $MX$ s is a function of the number of MLs (Hu *et al.*, 2015; Yang *et al.*, 2018; Dewandre *et al.*, 2019; Poudel, Villanova, and Barraza-Lopez, 2019; Ronneberger *et al.*, 2020), a feature observed in BP as well (Shulenburg *et al.*, 2015) that is related to the thickness-dependent spatial distribution of lone pairs. Such a dependence of  $|\mathbf{a}_{1,0} \times \mathbf{a}_{2,0}|$  on thickness is not observed in more traditional 2D materials such as graphene and TMDCs.

Leaving a detailed discussion of ultrathin film creation and characterization to Sec. III, Figs. 2(a) and 2(b) display few-ML SnS and SnTe films and provide striking examples of unexpected structure: indeed, while bulk SnS displays the  $Pcmn$  group symmetry, SnS grown on mica can take on a *ferroelectrically coupled* (sometimes labeled AA) stacking sequence for up to 15 MLs (Higashitarumizu *et al.*, 2020) [Fig. 2(a)], with a  $Pcmn$  group symmetry acquired by subsequent MLs on thicker films. Nonpolar, thick SnS can be switched into a ferroelectric phase by an external electric field (Bao *et al.*, 2019). Additional experimental  $MX$

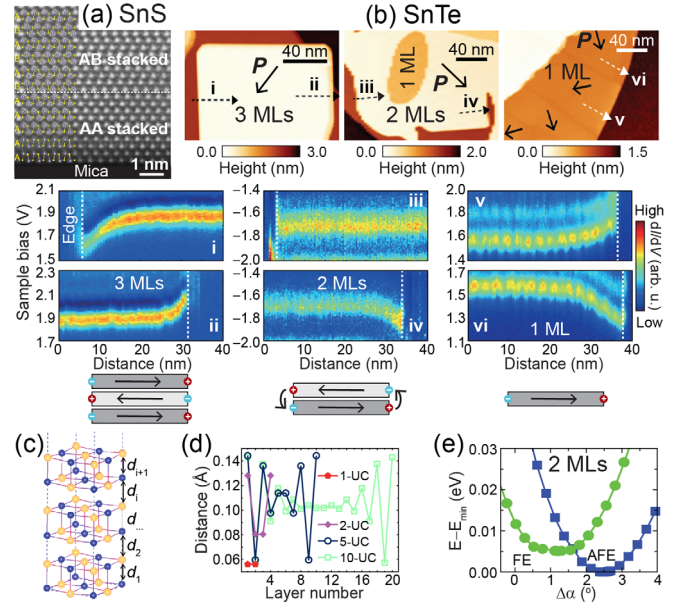


FIG. 2. (a) Cross-sectional STEM images of few-ML SnS grown on mica exhibit ferroelectric coupling for up to 15 MLs. From Higashitarumizu *et al.*, 2020. (b) Ultrathin SnTe grown on epitaxial graphene develops an antiferroelectric coupling, as demonstrated in subplots (i)–(vi) by band bending at the exposed edges of few-layer nanoplates. The lowermost diagrams indicate electrostatic interactions at exposed edges upon antiferroelectric coupling. From Chang *et al.*, 2019. (c),(d) Demonstration of layering in ferroelectrically coupled ultrathin SnTe by the uneven distance  $d_i$  among layers. From Yang *et al.*, 2018 and Liu *et al.*, 2018. (e) A SnTe bilayer with antiferroelectric (AFE) coupling has a lower total energy than a ferroelectric (FE) coupled one. From Kaloni *et al.*, 2019.

morphologies include GeS nanowires created along an axial screw dislocation (Sutter, Wimer, and Sutter, 2019) and the antiferroelectrically coupled ultrathin SnTe grown on metallic epitaxial graphene (Chang *et al.*, 2019), which is discussed next.

Bulk SnTe displays a metavalent  $R$  phase in the bulk. Grown on a metallic substrate, ultrathin SnTe flakes with a three-ML, bilayer, or ML thickness were characterized with a scanning tunneling microscope (STM), which permits one to elucidate their in-plane polarization  $\mathbf{P}$  from the band bending of the conduction band edge observed in Fig. 2(b). These STM spectra were captured along the dashed straight lines in Figs. 2(b)(i)–2(b)(vi) cutting through the nanoplates' edges (Chang *et al.*, 2016, 2019, 2020). (Additional details on the determination of  $\mathbf{P}$  are provided in Sec. III.) Band bending is almost nonexistent in SnTe bilayers, which implies an antipolar coupling among MLs and shows that the bonding of SnTe transitions from metavalent in the bulk to covalent in ultrathin films (Ronneberger *et al.*, 2020).

Three theoretical works (Liu *et al.*, 2018; Yang *et al.*, 2018; Ronneberger *et al.*, 2020) explained the layered nature of ultrathin SnTe. They were performed using either the local density approximation (LDA) (Perdew and Zunger, 1981) or the generalized gradient approximation implemented by Perdew, Burke, and Ernzerhof (1996) (PBE) for exchange correlation (XC) within density-functional theory (Martin,

2004) and assume a bulklike (i.e., *ferroelectric*) stacking of successive MLs in freestanding SnTe configurations such as the one depicted in Fig. 2(c).

Bulk SnTe features a Peierls distortion [a result of the competition among electron delocalization and localization (Ronneberger *et al.*, 2020)] that creates a net polarization along its diagonal and distorts a cubic lattice into a rhombohedral one. As a result, (i) a bulk u.c. has both an in-plane and an out-of-plane intrinsic polarization and, considering two atomic layers as a ML, (ii) consecutive MLs are coupled ferroelectrically. This is unlike O-*MX*'s, compounds with no net out-of-plane polarization and an antipolar coupling among successive MLs; see Fig. 1(a). Nevertheless, the depolarization field quenches the out-of-plane polarization of SnTe films (Liu *et al.*, 2018), creating an in-plane lattice expansion (Yang *et al.*, 2018) and a separation between MLs resulting in the layered structure seen in Fig. 2(d). Freestanding SnTe films with ferroelectric coupling have an intrinsically higher  $T_c$  than their bulk counterpart due to an interplay among hybridization interactions and Pauli repulsion. Additionally, electron sharing (Raty *et al.*, 2019) increases with decreasing thickness, imparting chemical bonds with a more covalent character (Ronneberger *et al.*, 2020).

Most computational works on *MX*'s that employ density-functional theory make use of the PBE approximation (Perdew, Burke, and Ernzerhof, 1996) to XC. Yet, as seen in Fig. 2(e), the experimentally observed antipolar coupling and the magnitude of  $\Delta\alpha$  on bilayer SnTe films is recovered when using self-consistent van der Waals (vdW-DF-cx) (Berland and Hyldgaard, 2014) interactions (Kaloní *et al.*, 2019). In any case, Figs. 2(a) and 2(b) indicate that the details of the initial surface are crucial for the type of atomistic structure formed by ultrathin *MX* films (Kooi and Wuttig, 2020).

### III. EXPERIMENTALLY AVAILABLE O-*MX* MLs

#### A. SnS MLs

Room-temperature in-plane ferroelectricity was demonstrated in few-ML SnS by a combination of piezoresponse-force microscopy (PFM), SHG, and electric transport experiments (Bao *et al.*, 2019). To overcome PFM's weakness in detecting the in-plane polarization of O-*MX*'s, SnS films were grown by molecular beam epitaxy (MBE) on corrugated graphite substrates so that  $\mathbf{P}$  was not perfectly perpendicular to the PFM tip and a finite polarization signal could be picked up. Ferroelectric domains and PFM hysteresis loops were resolved on 10 nm thick SnS films grown on mica, and a SHG signal was collected too. The modification of film morphology illustrates the difficulties of traditional techniques such as PFM to characterize ultrathin ferroelectric films with an in-plane  $\mathbf{P}$  switching, and the need to develop new techniques to characterize these ferroelectrics without changing morphology. Two-terminal devices were fabricated on a 15 nm thick SnS film grown on mica that was subsequently transferred onto a doped Si substrate covered by 300 nm thick SiO<sub>2</sub>. Hysteresis was found in the  $I$ - $V$  curves with a coercive field of 10.7 kV/cm and a maximum electric current on-off ratio of

TABLE IV. Spontaneous in-plane polarization  $P_0$  (in pC/m) as determined by density-functional theory with the PBE XC functional.

Material	$\bar{Z}$	$P_0^a$	$P_0^b$	$P_0^c$
GeS ML	24	484	480	486
GeSe ML	33	357	340	353
GeTe ML	42	...	...	308
SnS ML	33	260	240	265
SnSe ML	42	181	170	190
SnTe ML	51	...	...	50

<sup>a</sup>See Wang and Qian (2017b).

<sup>b</sup>See Rangel *et al.* (2017).

<sup>c</sup>Our calculations.

~100. Furthermore, the remnant polarization increased when a negative gate voltage was applied (Bao *et al.*, 2019).

The creation and characterization of SnS MLs was recently reported (Higashitarumizu *et al.*, 2020). SHG signals (a signature of lack of inversion symmetry and ferroelectricity that is discussed from a combined theory and experiment perspective in Sec. IX.C) were detected in SnS ML flakes grown by physical vapor deposition (PVD) on insulating mica. Two-terminal devices patterned onto these as-grown flakes display hysteresis in  $I$ - $V$  loops, yet another signature of ferroelectricity that is discussed in Sec. IV. In agreement with the ML arrangement depicted in Fig. 2(a), ferroelectricity is detected in SnS films composed of up to 15 MLs, including those composed of an even number of MLs. Ferroelectricity is unexpected in even-ML O-*MX* films because they are assumed to be centrosymmetric, lacking a net polarization according to the  $Pcmn$  group symmetry. A coercive field of 25 kV/cm was found for 9-ML thick SnS by electric transport measurements. An apparent remnant polarization as large as  $P_r \sim 3 \mu\text{C/m}$  was experimentally determined, much larger than the theoretical value of 240–265 pC/m listed in Table IV, and probably an artifact due to the relatively high conductance of SnS.

#### B. SnSe and SnTe MLs

The first experimentally discovered 2D ferroelectric in the O-*MX* family is the SnTe ML grown by MBE on metallic graphene (Chang *et al.*, 2016; Chang and Parkin, 2019) and characterized by STM (Chang *et al.*, 2016, 2019; Chang, Miller *et al.*, 2019) in Fig. 3(b). As seen in Figs. 3(c) and 3(d), SnSe MLs have been grown by MBE on graphene too (Chang *et al.*, 2020). Owing to the metallic substrate in which these are grown, the techniques employed to characterize ultrathin SnSe and SnTe films are different and complementary to those employed for SnS. Although STM is an unconventional tool to study ferroelectrics, its extreme surface sensitivity and access to the materials' local electronic structure are advantageous for studying ultrathin ferroelectric flakes with an in-plane intrinsic polarization, whereas PFM lacks sensitivity and may even damage ultrathin samples. STM measurements are helped by the fact that these ultrathin films are not insulators but rather semiconductors, such that a tunneling current into the metallic substrate can be established (Chang and Parkin, 2020).



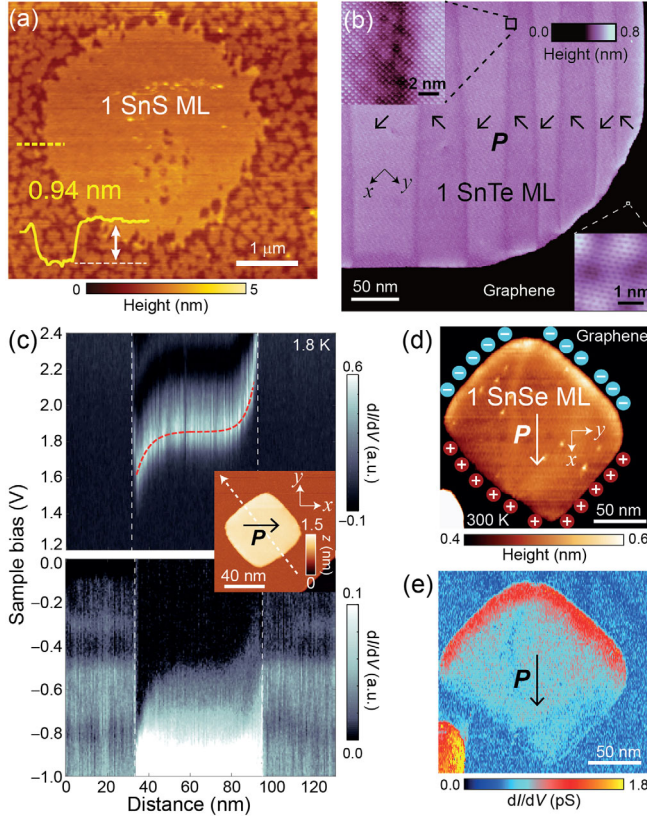


FIG. 3. (a) Atomic force microscopy topographic image of a SnS ML on mica. From Higashitarumizu *et al.*, 2020. (b) STM topography of a SnTe ML nanoplate on epitaxial graphene, with head-to-tail 90° domains having an intrinsic polarization  $\mathbf{P}$  indicated by arrows. From Chang *et al.*, 2016. (c) Low temperature  $dI/dV$  spectra across the dashed arrow in the inset for a SnSe ML nanoplate on graphene. (d),(e) Room-temperature STM topography and  $dI/dV$  for the SnSe ML: higher  $dI/dV$  implies a larger electronic charge. From Chang *et al.*, 2020.

Being a vector,  $\mathbf{P}$  has a magnitude  $P$ , an orientation, and a sense of direction. SHG can tell orientation only, while two-terminal electric measurements and STM [see Figs. 2(b)–2(e)] can determine both orientation and sense of direction. These three techniques require additional calibration to uncover the magnitude ( $P$ ), whose calculated values are listed in Table IV.

Similar to Figs. 2(b)(v) and 2(b)(vi), which show band bending of SnTe MLs on STM topography images, SnSe ML nanoplates display the band bending seen in Fig. 3(c) as a result of bound charges accumulated at the nanoplates' edges, reflecting the in-plane polarization  $\mathbf{P}$  of these 2D ferroelectrics. The direction of  $\mathbf{P}$  for SnSe and SnTe MLs [indicated by arrows with a  $\mathbf{P}$  label in Figs. 2(b) and 3(b)–3(e)] is identified by band bending at the nanoplate edges, and by the difference of lattice parameters  $a_1$  and  $a_2$  as extracted from atomically resolved STM images. Stripe-shaped ~90° “head-to-tail” domains are observed in SnTe monolayer plates in Fig. 3(b) (Chang *et al.*, 2016), while 180° domains are formed in SnSe MLs (Chang *et al.*, 2020). The different type of domains formed in SnSe and SnTe MLs has to do with a lattice commensuration of SnSe MLs on graphene (Chang *et al.*, 2020). A decrease of Sn vacancy concentration by 2 to 3

orders of magnitude was found in SnTe MLs with respect to bulk values (Chang *et al.*, 2016). Electronic band gaps of SnSe and SnTe MLs (obtained by the determination of the valence and conduction band edges via  $dI/dV$  measurements) are listed in Table VII.

Band bending disappears in SnTe MLs at 270 K (Chang *et al.*, 2016), but it can still be observed at 300 K in SnSe MLs, implying a robust in-plane ferroelectricity at room temperature in 2D SnSe. According to variable temperature  $dI/dV$  mapping experiments,  $T_c$  reaches 380–400 K for SnSe MLs, a promising magnitude for room-temperature applications. A theoretical description of thermally driven structural transformations of these MLs can be found in Sec. VII.

#### IV. SWITCHING THE DIRECTION OF $\mathbf{P}$ ON O-MX MLs: DEMONSTRATING FERROELECTRIC BEHAVIOR

O-MX MLs can be considered ferroelectrics only if their intrinsic electric polarization can be controllably switched by an external electric field. For this purpose, a two-terminal device was built by adding silver contacts to the SnS ML grown on mica, and the current  $I_D$  was measured as the drain bias  $V_D$  was swept from  $-1$  V to  $1$  V, then back to  $-1$  V. The result, shown in Fig. 4(a), demonstrates the ferroelectric resistive switching of SnS MLs.

In addition, the ferroelectric domains of SnSe MLs can be switched and domain walls moved by applying bias voltage pulses onto the graphene substrate away from a SnSe nanoplate as schematically laid out in Fig. 4(b). Figure 4(c) demonstrates the consecutive manipulation of 180° domains in a SnSe ML nanoplate. Demonstrating ferroelectric control, the polarization of the entire plate can be reversed by this approach. Statistical studies suggest a critical in-plane electric

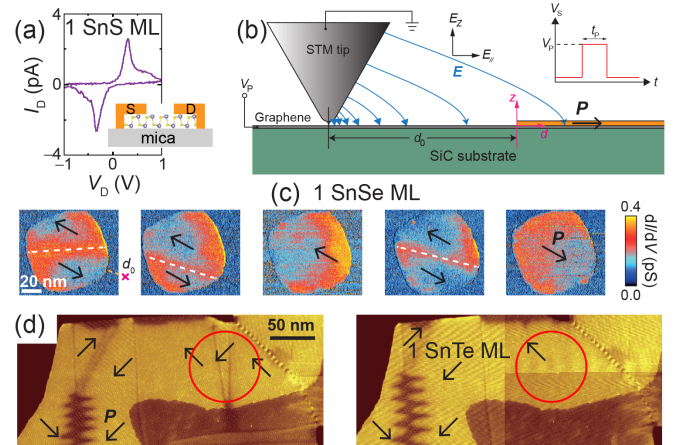


FIG. 4. (a) Ferroelectric resistive switching of a SnS ML on mica via source-drain bias. From Higashitarumizu *et al.*, 2020. (b) Ferroelectric switching of a SnSe ML is achieved by bias voltage pulses  $V_P$  applied on the STM tip at a point on the graphene substrate close to the SnSe ML plate. (c) Consecutive  $dI/dV$  images along a ferroelectric switching sequence of a SnSe ML at room temperature. The pulses were applied at the point indicated by a cross on the leftmost panel, and white dashed lines indicate a 180° domain wall. Adapted from Chang *et al.*, 2020. (d) Ferroelectric switching of a SnTe ML by a STM tip. From Chang *et al.*, 2016.



field of domain wall movement of  $E_{\parallel,c} = 1.4 \times 10^5$  V/cm. Polarization switching was also demonstrated by applying bias voltage pulses to the STM tip at the surface of SnTe MLs, which locally switches ferroelectric domains by the domain wall motion highlighted within circles in Fig. 4(d).

#### A. Polarization switching and ultrathin memories based on in-plane ferroelectric tunnel junctions

Ferroelectrics find applications in nonvolatile memories due to their switchable bistable ground states (Scott and Paz de Araujo, 1989). First-generation ferroelectric memories use the surface charge in a ferroelectric capacitor to represent data (Evans and Womack, 1988). As a result, discharging the capacitor to measure the charge destroys the stored data, and the capacitor must be recharged after reading. A second generation of these memories probes the ferroelectric polarization using a tunneling-electroresistance effect (Tsymbal and Kohlstedt, 2006) within a metal-ferroelectric-metal junction in which an *out-of-plane*  $\mathbf{P}$  exists within the ferroelectric thin film. The tunneling potential barrier is determined by the out-of-plane polarization in the ferroelectric layer.

It may be possible to create *in-plane ferroelectric memories* by adding an insulator and a top gate to the two-terminal device shown in Fig. 4(a). Indeed, if  $\mathbf{P}$  points in plane, as in O-MX MLs, the band bending at the ferroelectric materials' edge can be read out with metal contacts (Shen, Liu *et al.*, 2019). As depicted by the dependency of  $I_D$  on  $V_D$  in Fig. 4(a), the upward or downward band bending drawn in Fig. 5(a) could represent the “on” or “off” state, respectively, so that the stored information is read nondestructively.

Figure 5(b) shows a ferroelectric thin film sandwiched between a metallic substrate and a wide-band-gap insulator. The writing and reading electrodes are deposited at opposite edges of the top insulator. If  $\mathbf{P}_0$  lies in plane along the  $+x$  direction, it will induce opposite net charges at the ferroelectric boundaries along that direction. Depending on the polarization direction (either  $+x$  or  $-x$ ), the band bending near the reading electrode could be upward or downward, leading to on and off states [Figs. 5(c) and 5(d), respectively].

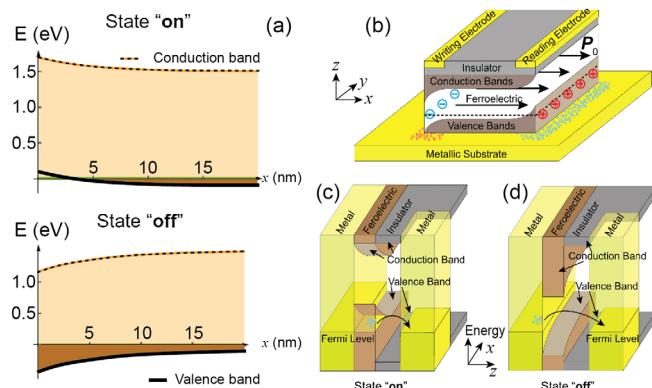


FIG. 5. (a) Schematics of upward (top) and downward (bottom) band bending near a ferroelectric's edge for a chemical potential near the valence band edge. The Fermi energy of the electrode was set at  $E = 0$ . (b)–(d) Device schematics (b) and band diagrams for the on (c) and off (d) states. Adapted from Shen, Liu *et al.*, 2019.

Reading is nondestructive because the electric field generated by the reading voltage is perpendicular to the ferroelectric's polarization. Using Landauer's conductance formalism and suitably chosen parameters, currents of the order of a micro-ampere and electric current on-off ratios of the order of  $10^4$  have been predicted (Shen, Liu *et al.*, 2019); see Shen, Fang *et al.* (2019) and Kwon *et al.* (2020) for additional memory devices based on O-MX's.

#### V. LINEAR ELASTIC PROPERTIES, AUXETIC BEHAVIOR, AND PIEZOELECTRICITY OF O-MX MLs

The physical properties of 2D materials can be tuned by strain (Amorim *et al.*, 2016; Naumis *et al.*, 2017). In linear elasticity theory, the strain tensor is defined as  $\epsilon_{ij} \simeq (1/2)(\partial u_i / \partial x_j + \partial x_j / \partial x_i)$ , where  $\mathbf{u} = (u_x, u_y, u_z)$  is the displacement field  $\mathbf{u} = \mathbf{r} - \mathbf{r}_0$  away from a structural configuration that minimizes the structural energy.

The constitutive relation establishes a linear dependence among the stress tensor  $\sigma_{ij}$  and  $\epsilon_{ij}$ :  $\sigma_{ij} = C_{ijkl}\epsilon_{kl}$ , where  $C_{ijkl}$  is the elasticity tensor. Symmetry restrictions on O-MX MLs imply that only  $C_{xxxx}$ ,  $C_{xyxy}$ ,  $C_{yyyy}$ , and  $C_{xyxy}$  are nonzero (Fei *et al.*, 2015; Gomes, Carvalho, and Castro Neto, 2015); subindices  $xx$  and  $yy$  label compressive or tensile (normal) strain, and  $xy$  is a shear strain. Using Voigt notation ( $xx \rightarrow 1$ ,  $yy \rightarrow 2$ , and  $xy \rightarrow 6$ ), these entries of the elasticity tensor are commonly written as  $C_{11}$ ,  $C_{12}$ ,  $C_{22}$ , and  $C_{66}$ , and their magnitudes are listed in Table V.

$C_{11}$ ,  $C_{22}$ , and  $C_{12}$  are obtained by fitting against the elastic energy landscape shown in Fig. 6(a), in which  $\epsilon_1 = \Delta a_1 / a_{1,0} = (a_1 - a_{1,0}) / a_{1,0}$  and  $\epsilon_2 = \Delta a_2 / a_{2,0}$ . Consistent with the change in area in going from the bulk to a ML, elastic constants tend to be slightly softer in MLs than in the bulk. Gomes, Carvalho, and Castro Neto (2015) provided the Young's modulus for GeS, GeSe, SnS, and SnSe as well, which is an order of magnitude smaller than its magnitude of 340 N/m for graphene (Lee *et al.*, 2008). Additionally,  $C_{11}$  and  $C_{22}$  are smaller than their values for MoS<sub>2</sub> and GaSe MLs, which are listed in Table V as well. The shear elastic coefficient  $C_{66}$  in Table V is as small as  $C_{11}$ : shear strain changes the magnitude of  $\Delta\alpha$  in Fig. 1(c), implying that distortions by such an angle are as soft as a compression or elongation along the  $\mathbf{a}_1$  direction. In light of Table V, O-MX MLs are *soft* 2D materials with anisotropic elastic properties.

The Poisson's ratio  $\nu$  determines the rate of contraction in transverse directions under longitudinal uniaxial load. Most

TABLE V. Relaxed-ion components of the elastic tensor  $C_{ij}$  for O-MX MLs in N/m. Adapted from Gomes, Carvalho, and Castro Neto, 2015 and Fei *et al.*, 2015.

Material	$\bar{Z}$	$C_{11}$	$C_{22}$	$C_{12}$	$C_{66}$
GeS ML	24	15.24–20.87	45.83–53.40	21.62–22.22	18.59
GeSe ML	33	13.81–20.30	46.62–50.16	17.49–19.45	23.19
SnS ML	33	14.91–20.86	35.97–43.15	15.22–18.14	19.56
SnSe ML	42	19.61–19.88	40.86–44.49	16.36–18.57	13.70
MoS <sub>2</sub> ML <sup>a</sup>		130	130	32	...
GaSe ML <sup>b</sup>		83	83	18	...

<sup>a</sup>See Duerloo, Ong, and Reed (2012).

<sup>b</sup>See Li and Li (2015).

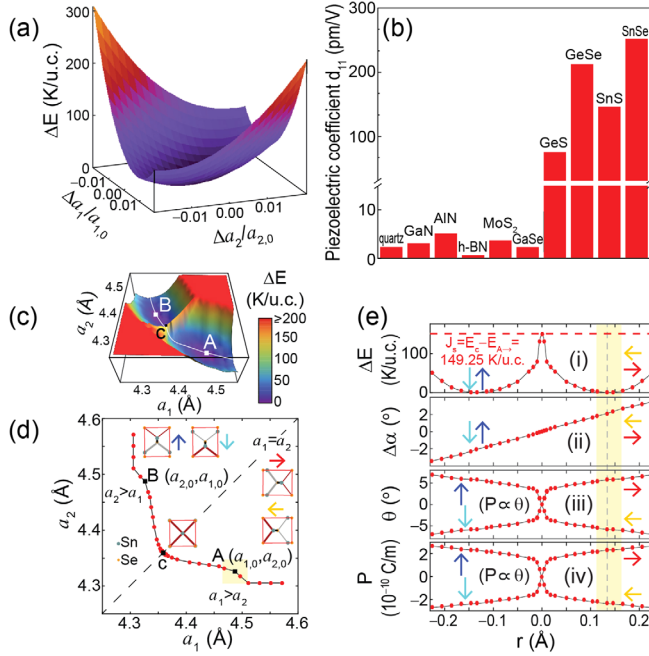


FIG. 6. (a) Elastic energy landscape of a SnSe ML (in units of K/u.c.) as a function of uniaxial strain along the  $a_1$  and  $a_2$  directions. Adapted from Gomes, Carvalho, and Castro Neto, 2015. (b) Piezoelectric coefficient  $d_{11}$  of GeS, GeSe, SnS, and SnSe MLs and other known piezoelectric materials. Adapted from Fei *et al.*, 2015. (c) Elastic energy landscape over a larger range of values for  $a_1$  and  $a_2$ ; point A corresponds to the ground state unit cell shown in Fig. 1(c). (d) Two-dimensional lowest-energy path joining degenerate ground states A and B. The shaded rectangle corresponds to  $\pm 0.5\%$  strain. (e) Change in energy  $\Delta E$ ,  $\Delta\alpha$ ,  $\theta$ , and  $P$  when going through the path shown in (c). The dashed vertical line cuts through  $\Delta E = 0$  and thus shows  $\Delta\alpha_0$ ,  $\theta_0$ , and  $P_0$ . Adapted from Barraza-Lopez *et al.*, 2018.

materials have a positive Poisson's ratio but, as discussed by Jiang and Park (2014), Gomes, Carvalho, and Castro Neto (2015), Kong *et al.* (2018), and Liu, Niu *et al.* (2019) and summarized in Table VI, the buckled structure of O-MX MLs depicted in Fig. 1(c) confers them with negative ratios when the out-of-plane ( $z$  direction) is considered. The subscripts of  $\nu_{ij}$  in Table VI indicate the linear Poisson's ratio along the  $i$  direction due to a load along the  $j$  direction as defined in Fig. 1(c). Negative values of  $\nu_{ij}$  are indicative of *auxetic* behavior, i.e., an elongation (compression) occurs along the  $i$  direction when these 2D materials are elongated

TABLE VI. Sign of  $\Delta h_0$  and linear Poisson's ratio  $\nu_{ij}$  of a BP ML and of O-MX MLs. Negative values of  $\nu_{ij}$  indicate auxetic behavior. Adapted from Jiang and Park, 2014, Kong *et al.*, 2018, and Liu, Niu *et al.*, 2019.

Material	$\bar{Z}$	$\Delta h_0$	$\nu_{yx}$	$\nu_{xy}$	$\nu_{zx}$	$\nu_{zy}$
BP	15	0	0.400	0.930	0.046	-0.027
GeS ML	24	+	0.420	1.401	-0.208	0.411
GeSe ML	33	-	0.391	1.039	0.583	-0.433
SnS ML	33	+	0.422	0.961	-0.004	0.404
SnSe ML	42	+	0.423	0.851	-0.210	0.352
SnTe ML	51	-	0.423	0.480	0.242	0.109

(compressed) along the  $j$  direction. According to Table VI, there is a direct correlation between a positive  $\Delta h_0$  value in Fig. 1(a) and a negative  $\nu_{zx}$  value.

The third-order piezoelectric tensor  $d_{ijk}$  links  $\Delta \mathbf{P} = \mathbf{P} - \mathbf{P}_0$  with the applied strain  $\epsilon_{jk}$ . Using Voigt notation for the last two entries of the piezoelectric tensor and for the applied strain, Fig. 6(b) displays a 10 times larger magnitude of  $d_{11}$  for GeS, GeSe, SnS, and SnSe than the piezoelectric coefficients of quartz and other polar materials (Fei *et al.*, 2015).

## VI. STRUCTURAL DEGENERACIES AND ANHARMONIC ELASTIC ENERGY OF O-MX MLs

As it turns out, the elastic energy landscape for which elastic properties were discussed in Sec. V is nonlinear. Its nonlinearity underpins the highly anharmonic vibrational properties and a propensity of O-MX MLs for sudden changes in ferroelectric, structural, electronic, spin, and optical properties with temperature.

Turning the  $\Delta a_1/a_{1,0} = (a_1 - a_{1,0})/a_{1,0}$  axis in Fig. 6(a) into  $a_1$  and  $\Delta a_2/a_{2,0}$  into  $a_2$ , and increasing the range for both  $a_1$  and  $a_2$  from which the structural energy  $E(a_1, a_2) = \Delta E(a_1, a_2) = E(a_1, a_2) - E(a_{1,0}, a_{2,0})$  shown in Fig. 6(c) ensues. Given that  $E(a_{1,0}, a_{2,0}) = E(a_{2,0}, a_{1,0})$  on 2D materials with a rectangular u.c. ( $a_{1,0} > a_{2,0}$ ), the elastic energy landscape has two degenerate structures, labeled A and B in Fig. 6(c) (Mehboudi, Dorio *et al.*, 2016; Wang and Qian, 2017b). O-MX's have eight degenerate u.c.'s, occurring upon a mirror reflection with respect to the  $x$ - $z$  or  $x$ - $y$  planes, or by an exchange of  $x$  and  $y$  coordinates (Mehboudi, Dorio *et al.*, 2016). Nevertheless, an inversion with respect to the  $x$ - $y$  plane does not change the orientation or the sense of direction of  $\mathbf{P}_0$  and is usually disregarded when describing degeneracies for that reason; the four remaining degenerate ground state u.c.'s are displayed as an inset in Fig. 6(d). They have projections  $\mathbf{p}_0 \rightarrow, \uparrow, \leftarrow,$  and  $\downarrow$  that are reminiscent of discrete clock models, well-known tools for discussing order-by-disorder 2D transformations in statistical mechanics (Potts, 1952) that provide important insight into the finite temperature behavior of O-MX MLs (Mehboudi, Dorio *et al.*, 2016).

The saddle point  $c$  in Fig. 6(c) indicates the minimum elastic energy necessary to switch in between ferroelectric states A and B. It is situated at  $(a_c, a_c)$ , with  $a_c = (1 - 1/\sqrt{2})a_{1,0} + a_{2,0}/\sqrt{2}$  (Poudel, Villanova, and Barraza-Lopez, 2019). The fivefold coordinated u.c. at point  $c$  is paraelectric (Mehboudi, Dorio *et al.*, 2016) and it belongs to symmetry group 129 ( $P4/nmm$ , or  $Pmm4/n$  with our choice of axes) (Villanova, Kumar, and Barraza-Lopez, 2020).  $J_s$  is the energy difference between the fivefold coordinated paraelectric u.c. at point  $c$  and any of the degenerate ferroelectric ground states (i.e., the one at point A with polarization along the positive  $x$  direction):  $J_s = E_c - E_{A,\rightarrow} = E(a_c, a_c) - E(a_{1,0}, a_{2,0})$ .  $J_s$  indicates the ease of a ferroelastic transformation among a pair of degenerate structures shown in Fig. 6(d). As discussed in Sec. VII, it is a qualitative estimator of the critical temperature  $T_c$  at which a ferroelectric-to-paraelectric transition takes place in these 2D materials. [ $a_{1,0} = a_{2,0} = a_c$  for PbX MLs in Fig. 1(d), which hence have a single nondegenerate structural ground state and  $J_s = 0$ .]

The white path  $r(a_1, a_2)$  in Fig. 6(c) provides the lowest-energy distortion that is necessary to turn degenerate structure  $A$  into  $B$  elastically, and it is projected onto a 2D plot in Fig. 6(d). For a SnSe ML, points  $A$  and  $B$  are located at distances  $r = 0.134$  and  $-0.134$  Å along this path; point  $c$  is located at  $r = 0$  Å. The range of values utilized to extract linear elastic properties in Sec. V can be seen as a yellow (light gray) rectangle in Fig. 6(d).

The anharmonicity of the elastic energy landscape is established by the double-well potential  $\Delta E(r)$  seen in Fig. 6(e)(i). The magnitude of  $J_s$  for a SnSe ML [as computed with the vdW-DF-cx (Berland and Hyldgaard, 2014) XC functional] can also be seen in that plot. The dependency of  $\Delta E$  on the path coordinate  $r$  is *bistable* (i.e., fundamentally nonharmonic). The evolution of  $\Delta\alpha$ ,  $\theta$ , and the polarization  $P$  along  $r$  [including the four possible orientations of  $\mathbf{p}$  ( $\mathbf{P}$ )] is displayed in Figs. 6(e)(ii)–6(e)(iv). The area in yellow (light gray) in Fig. 6(e) corresponds to the  $\pm 0.5\%$  strain within which  $\Delta E$  can be fitted to a parabola, and where  $\Delta\alpha$ ,  $\theta$ , and  $P$  are linear on  $r$ .

The vertical dashed line crossing through  $\Delta E = 0$  shows  $\Delta\alpha_0$ ,  $\theta_0$ , and  $P_0$ ; i.e., the ground state magnitudes of these variables in a u.c. like the one seen in Fig. 1(c). The angle  $\Delta\alpha$  is positive for  $r > 0$  ( $a_1 > a_2$ ), zero at  $r = 0$  ( $a_1 = a_2$ ), and negative for  $r < 0$  ( $a_1 < a_2$ ). The angle  $\theta$ , in turn, points along the positive or negative  $x$  direction when  $r > 0$ , it is zero at  $r = 0$ , and it points along  $\pm y$  when  $r < 0$ .  $\theta$  and  $P$  are linearly proportional ( $P \propto \theta$ ) and  $P = 0$  when  $\theta = 0$  and  $\Delta\alpha = 0$  in an elastic transformation in which lattice parameters can vary. The possibility of switching  $\mathbf{P}$  gives rise to a combined ferroelectricity and ferroelasticity, i.e., to multiferroic behavior in O-MX MLs (Wu and Zeng, 2016; Wang and Qian, 2017b).

## VII. STRUCTURAL PHASE TRANSITION AND PYROELECTRIC BEHAVIOR OF O-MX MLs

Structural degeneracies underpin strong anharmonic elastic properties, soft phonon modes, and structural phase transitions. Taking  $J_s$  (the relevant energy scale in the system) as an *ad hoc* exchange parameter, a clock model with  $r = 4$  degenerate states yields the following relation among  $T_c$  and  $J_s$ :  $T_c = 1.136J_s$  (Potts, 1952). The Potts model also has a prescription in case only a subset of two degenerate states is available (e.g.,  $\rightarrow$  and  $\leftarrow$ ), which could occur in a constrained scenario in which  $a_1$  and  $a_2$  keep zero-temperature magnitudes (Fei, Kang, and Yang, 2016): calling  $J_r$  the energy barrier under such a constrained configuration, Potts dictates that  $T'_c = 2.272J_r$  (Potts, 1952). Numerical calculations indicate that  $J_r \geq 1.4J_s$  so that  $T'_c \geq 2.8T_c$ . The message is that structural constraints lead to an increased  $T_c$ .

The ferroelectric-to-paraelectric transition temperature  $T_c$  of O-MX MLs calculated at the density-functional theory level (Martin, 2004) has a strong dependency on the choice of XC functional, and it is unclear that the PBE XC functional ought to provide the most accurate description of the thermal behavior of O-MX's. The strong dependency of  $T_c$  on the XC functional can be already foreseen in the magnitude of  $J_s$  displayed in Fig. 7(a), which contains predictions with the LDA, PBE, multiple nonempirical van der Waals

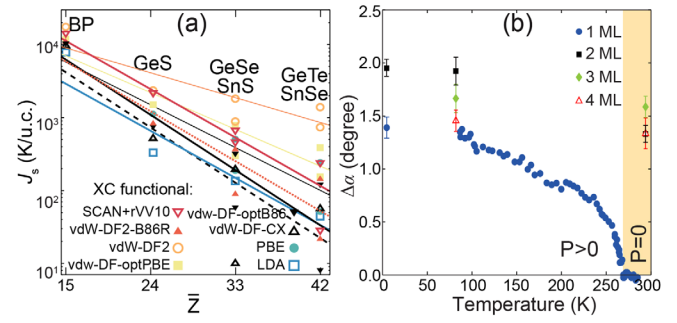


FIG. 7. (a) Exponential dependency of  $J_s$  on  $\bar{Z}$ . The dependency of  $J_s$  (and therefore of  $a_{1,0}$ ,  $a_{2,0}$ ,  $\Delta\alpha_0$ ,  $P_0$ , and  $\theta_0$ ) on the XC functional employed is also shown. From Poudel, Villanova, and Barraza-Lopez, 2019. (b) Experimental thermal dependency of  $\Delta\alpha$  for few-layer SnTe on epitaxial graphene. A paraelectric phase ( $P = 0$ ) ensues at temperatures above  $T_c = 270$  K in SnTe MLs. Adapted from Chang *et al.*, 2016.

implementations (Berland *et al.*, 2015), and even the recent SCAN+rVV10 (Peng *et al.*, 2016) XC functional (Poudel, Villanova, and Barraza-Lopez, 2019).

*Ab initio* molecular dynamics (AIMD) calculations performed on freestanding SnSe MLs using the  $NPT$  ensemble (in which containing walls are allowed to move to accommodate for thermal expansion) provide the following information: (i)  $T_c$  is larger in GeSe MLs and bilayers than it is in SnSe MLs and bilayers, owing to the smaller  $\bar{Z}$  and hence larger barrier  $J_s$  [Fig. 7(a)] for GeSe; and (ii) for a given O-MX,  $T_c$  increases with increasing number of MLs (Chang *et al.*, 2016; Mehboudi, Fregoso *et al.*, 2016). A slight dependency of  $T_c$  on the size of the simulation supercell has been documented too (Mehboudi, Fregoso *et al.*, 2016; Barraza-Lopez *et al.*, 2018). In agreement with  $J_s$ 's inverse dependency on  $\bar{Z}$ , experiments indicate a  $T_c$  larger than 400 K for SnSe MLs ( $\bar{Z} = 42$ ) on graphene (Chang *et al.*, 2020), and  $T_c = 270$  K for SnTe MLs ( $\bar{Z} = 51$ ) on the same substrate [Fig. 7(b) (Chang *et al.*, 2016)].

The upper row in Fig. 8(a) shows a progression of  $T_c$  estimates for a freestanding SnSe ML that were obtained using the vdW-DF-cx XC functional (Berland and Hyldgaard, 2014). From left to right, the figure displays the thermal behavior of  $\Delta\alpha$  and  $\theta$  when (i) using the  $NPT$  ensemble (in which containing walls move so that the material remains at atmospheric pressure), (ii) the  $NVT$  ensemble (in which the supercell lattice vectors are fixed to their zero-temperature magnitudes and containing walls do not move), and (iii) a unidirectional optical vibration (UOV) model in which only one vibrational mode out of 12 is employed and the containing walls do not move either (Fei, Kang, and Yang, 2016). The point is that (as already foreseen by the previously mentioned Potts model)  $T_c$  increases with added constraints. Energy barriers  $J_s$  and  $J_r$  are listed in Fig. 8 too.

AIMD calculations carried out with the  $NPT$  ensemble yield the smallest magnitude of  $T_c$  (212 K). Although the compounds are not the same (a freestanding SnSe ML in calculations and a SnTe ML on graphene in experiment), the decay of  $\Delta\alpha$  in the calculations seen in Fig. 8(a)(i) indicates a phenomenology consistent with experiment in Fig. 7(b) (Chang *et al.*, 2016; Barraza-Lopez *et al.*, 2018).



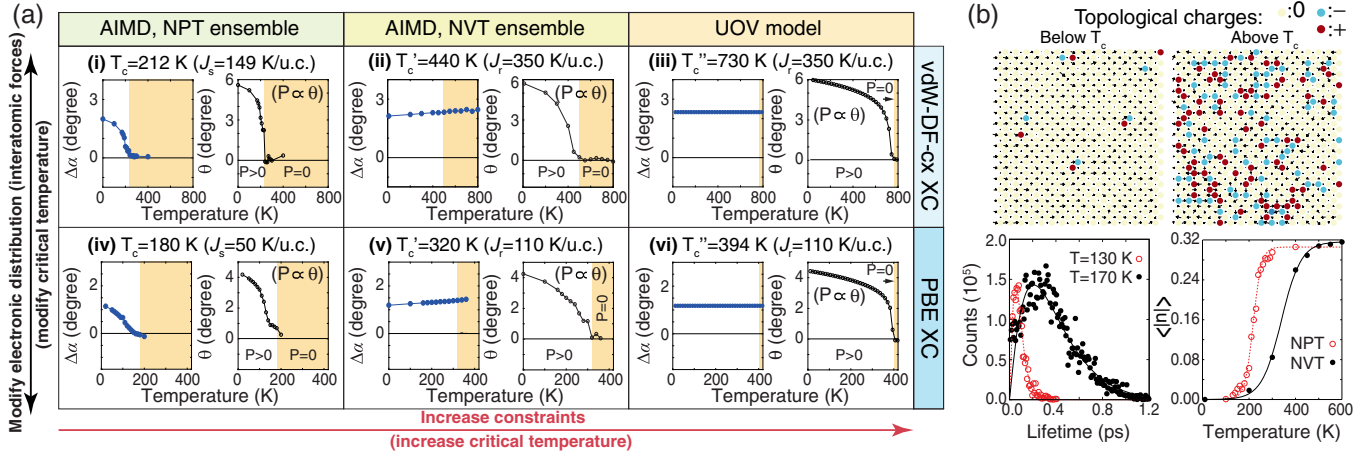


FIG. 8. (a) Temperature dependence of  $\Delta\alpha$  and  $\theta$  for a SnSe ML in AIMD calculations employing two XC functionals and obtained within (i),(iv) the *NPT* and (ii),(v) *NVT* ensembles. (iii),(vi) Results from the more constrained unidirectional optical vibration (UOV) model. The ferroelectric phase occurs when  $\theta > 0$ . Note that  $\Delta\alpha = 0$  implies  $\theta = 0$ , but that  $\theta = 0$  does not necessarily imply  $\Delta\alpha = 0$ . (b) The structural transformations described by AIMD can be understood in terms of a fluctuating connectivity (i.e., topology) of these 2D ferroelectrics. Pairs of topological charges have a temperature-dependent lifetime and their number saturates at temperatures within  $T_c$ . Results in (b) were obtained using the vdW-DF-cx functional. Adapted from Villanova, Kumar, and Barraza-Lopez, 2020.

When constraining the SnSe ML by not permitting its area to increase at finite temperature, the structural transition within the *NVT* ensemble necessarily requires additional thermal energy to take place, raising  $T'_c$  up to 440 K and displaying  $\Delta\alpha > 0$  at  $T_c$ . Despite the existence of nearly degenerate vibrational modes oscillating along both the  $x$  and  $y$  directions, the highly constrained UOV model permits an optical vibration only along the  $x$  direction (an oscillatory mode valid only at the  $\Gamma$  point) and thus yields the largest  $T''_c = 730$  K, still showing  $\Delta\alpha > 0$  at  $T''_c$  as  $a_1$  and  $a_2$  are kept fixed [Eq. (1)]. The experimental  $\Delta\alpha$  [Fig. 7(b)] is not a relevant order parameter in Figs. 8(a)(ii) and 8(a)(iii) because  $a_1$  and  $a_2$  retain their zero-temperature values in these models.

The increasing sequence of critical temperatures observed with increasing mechanical constraints is independent of the XC approximation, as the lower row in Fig. 8(a) shows a similar phenomenology when the PBE XC functional is employed.  $T_c$ ,  $T'_c$ , and  $T''_c$  have smaller values than those obtained with the vdW-DF-cx XC functional (Villanova, Kumar, and Barraza-Lopez, 2020). As illustrated in Fig. 8(b), the structural transition is underpinned by changes in the connectivity of the 2D lattice as the two atoms defining the angle  $\theta$  in Fig. 1(a) rotate about the out-of-plane  $z$  axis; this change in connectivity confers a topological character to the structural transformation (Kosterlitz, 2016; Villanova, Kumar, and Barraza-Lopez, 2020; Xu *et al.*, 2020).

Pyroelectricity is the creation of electricity by a temperature gradient. Given the direct proportionality between  $\theta$  and  $P$ , the temperature derivative of  $\theta$  in Fig. 8(a) gives direct insight into the pyroelectric properties of O-MX's (Mehboudi, Fregoso *et al.*, 2016).

The effects of substrates such as Ni, Pd, Pt, Si, Ge, CaO, and MgO on the morphology and properties of SnTe MLs (including charge transfer and atomistic distortions) have been studied (Fu, Liu, and Yang, 2019). Still, the effect of the substrate-MX interaction on the transition temperature is an important avenue

for further theory. Along these lines, the elastic energy barriers  $J_s$  of GeSe, GeTe, SnS, SnSe, and SnTe MLs have been shown to vanish under a modest hole doping of  $0.2|e|/\text{u.c.}$ , where  $e$  is the electron's charge (Du, Pendergrast, and Barraza-Lopez, 2020; Zhu, Lu, and Wang, 2020).

It was indicated in Sec. II that O-MX's are isostructural to BP. This makes BP MLs doubly degenerate upon exchange of the  $x$  and  $y$  coordinates and suggests that BP MLs may also undergo a phase transition at finite temperature. Nevertheless, considering  $J_s$  as an approximate measure of  $T_c$ , one observes that  $J_s > 1000$  K/u.c. for BP in Fig. 7(a) regardless of the XC functional. Such a magnitude is so large that a BP ML melts rather than undergoing a 2D ferroelastic-to-paraelastic transition (Mehboudi, Dorio *et al.*, 2016), thus explaining the lack of *thermally driven* 2D phase transitions in BP MLs. [BP MLs have been shown to undergo temperature-independent 2D phase transitions by mechanical strain (Rodin, Carvalho, and Castro Neto, 2014b).] The propensity to undergo thermally driven 2D transitions is a crucial physical behavior setting O-MX MLs apart from other 2D materials such as graphene, TMDC MLs with a  $2H$  symmetry, and BP MLs.

## VIII. ELECTRONIC, VALLEY, AND SPIN PROPERTIES OF O-MX MLs

### A. Electronic band structure

TMDC MLs such as  $2H$ -MoS<sub>2</sub> display an indirect-to-direct band gap crossover at the ML limit. As indicated in Table VII, the experimental band gap of MoS<sub>2</sub> increases from 1.29 eV in the bulk up to 1.90 eV in a ML due to quantum confinement (Mak *et al.*, 2010), and the valence band maxima (VBM) and conduction band minima (CBM) are both located at the high-symmetry  $\pm K$  points in these MLs. Similarly, quantum confinement leads to an increase of the electronic band gap of BP (Table VII), and its electronic bands are highly

TABLE VII. Electronic band gap (in eV) for BP, O-*MX*'s, and MoS<sub>2</sub> (ML and bulk) with PBE and Heyd-Scuseria-Ernzerhof (HSE) XC functionals (Heyd, Scuseria, and Ernzerhof, 2003), from *GW* calculations (Deslippe *et al.*, 2012), or experiment. We computed the PBE values for GeTe and SnTe MLs and bulk SnTe.

Material	$\bar{Z}$	PBE (ML)	HSE (ML)	<i>GW</i> (ML)	Expt. (ML)	PBE (bulk)	HSE (bulk)	Expt. (bulk)
BP	15	0.90 <sup>a</sup>	1.66 <sup>a</sup>	2.2 <sup>b</sup>		0.07 <sup>a</sup>	0.39 <sup>a</sup>	0.33 <sup>c</sup>
GeS	24	1.65 <sup>a</sup>	2.32 <sup>a</sup>	2.85 <sup>d</sup>		1.22 <sup>a</sup>	1.81 <sup>a</sup>	1.70–1.96 <sup>e</sup>
GeSe	33	1.18 <sup>a</sup>	1.54 <sup>a</sup>	1.70–1.87 <sup>d,f</sup>		0.57 <sup>a</sup>	1.07 <sup>a</sup>	1.14 <sup>g</sup>
GeTe	42	0.87				0.33 <sup>h</sup>	0.65 <sup>h</sup>	0.61 <sup>i</sup>
SnS	33	1.38 <sup>a</sup>	1.96 <sup>a</sup>			0.82 <sup>a</sup>	1.24 <sup>a</sup>	1.20–1.37 <sup>e</sup>
SnSe	42	0.96 <sup>a</sup>	1.44 <sup>a</sup>	1.63 <sup>f</sup>	2.1 <sup>j</sup>	0.54 <sup>a</sup>	1.00 <sup>a</sup>	0.90 <sup>k</sup>
SnTe	51	0.68			1.6 <sup>l</sup>	0.13		0.30 <sup>m</sup>
MoS <sub>2</sub>	...	1.63 <sup>n</sup>	2.11 <sup>n</sup>		1.90 <sup>o</sup>	0.98 <sup>n</sup>	1.46 <sup>n</sup>	1.29 <sup>o</sup>

<sup>a</sup>See Gomes and Carvalho (2015).

<sup>b</sup>See Wang *et al.* (2015).

<sup>c</sup>See Keyes (1953).

<sup>d</sup>See Gomes *et al.* (2016).

<sup>e</sup>See Malone and Kaxiras (2013).

<sup>f</sup>See Shi and Kioupakis (2015).

<sup>g</sup>See Vaughn *et al.* (2010).

<sup>h</sup>See Di Sante *et al.* (2013).

<sup>i</sup>See Park *et al.* (2009).

<sup>j</sup>See Chang *et al.* (2020).

<sup>k</sup>See Parenteau and Carlone (1990).

<sup>l</sup>See Chang *et al.* (2016).

<sup>m</sup>See Dimmock, Melngailis, and Strauss (1966).

<sup>n</sup>See Shi *et al.* (2017).

<sup>o</sup>See Mak *et al.* (2010).

anisotropic. The VBM and CBM are both located at the  $\Gamma$  point in BP MLs (Tran *et al.*, 2014).

Tritsaris, Malone, and Kaxiras (2013) studied the electronic properties of SnS down to the ML limit. As indicated in Table VII, the electronic band gap increases as these materials are thinned down. Nevertheless (and unlike the case for 2*H*-TMDs and BP MLs), the VBM and CBM are not located at high-symmetry points in the first Brillouin zone (BZ).

With reciprocal lattice vectors  $\mathbf{b}_1 = (2\pi/a_{1,0})(1, 0, 0)$  and  $\mathbf{b}_2 = (2\pi/a_{2,0})(0, 1, 0)$ , the high-symmetry points depicted as

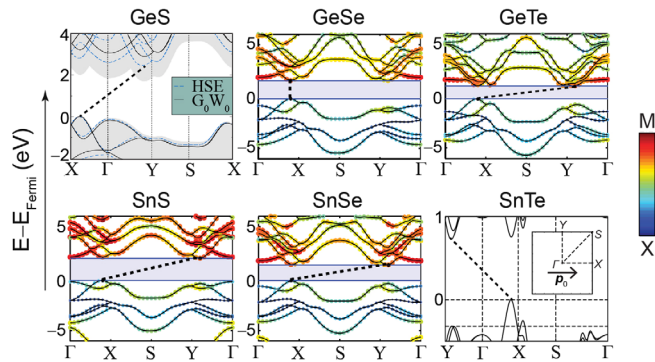


FIG. 9. Electronic band structure of O-*MX* MLs. With the exception of the SnTe ML, these calculations were carried out with the HSE06 XC functional. GeSe MLs have direct band gaps, and the GeTe ML subplot was modified to account for an indirect band gap smaller by just 0.01 eV than the direct band gap. The inset in the SnTe subplot displays the high-symmetry points and the direction of  $\mathbf{p}_0$ . Adapted from Singh and Hennig, 2014, Gomes *et al.*, 2016, and Chang, Miller *et al.*, 2019.

an inset within the SnTe subplot in Fig. 9 are  $\Gamma$ ,  $X$  (located at  $\mathbf{b}_1/2$ ),  $Y$  (at  $\mathbf{b}_2/2$ ), and  $S$  (at  $\mathbf{b}_1/2 + \mathbf{b}_2/2$ ). O-*MX* MLs have their VBM away from high-symmetry points, at about  $\pm(0.74 - 0.84)X$  and their CBM at about  $\pm(0.74 - 0.84)Y$  for an indirect band gap. The exception is GeSe, having a CBM at  $\pm 0.80X$  and an indirect band gap (Singh and Hennig, 2014; Gomes and Carvalho, 2015; Shi and Kioupakis, 2015; Gomes *et al.*, 2016). Electronic band structure calculations within the *GW* approximation (Deslippe *et al.*, 2012) were carried out by Shi and Kioupakis (2015), Tuttle, Alhassan, and Pantelides (2015), and Gomes *et al.* (2016); their band gaps are listed in Table VII. The electronic band structure of O-*MX*'s turns more (less) anisotropic for lighter (heavier) compounds, for which  $a_{1,0}/a_{2,0}$  in Fig. 1(d) takes on larger (smaller) values. Going across chemical elements, the band gap for O-*MX* MLs in Table VII is tunable with  $\bar{Z}$ : it takes its largest magnitude for lighter compounds (GeS,  $\bar{Z} = 24$ ) and it is smaller for the heaviest compound (SnTe,  $\bar{Z} = 51$ ).

From an experimental perspective, hole-doped SnTe MLs acquire a domain structure observed as dark vertical lines in Figs. 3(b) and 10(a). As seen in Figs. 10(b) and 10(d), the spatially resolved  $dI/dV$  spectra (proportional to the sample's LDOS) features electronic standing wave patterns across domains for energies below the VBM that provide indirect information into these materials' electronic properties.

The standing wave patterns observed at 4 K in SnTe MLs are induced by the electronic band mismatch at the two sides of a 90° domain wall [see domains with  $\mathbf{P}$  forming  $\sim 90^\circ$  angles in Figs. 2(b) and 3(b)]. As Fig. 9 shows, the valence band apexes along the  $\Gamma$ - $Y$  direction are 0.3 eV below those seen along the  $\Gamma$ - $X$  direction. Such a mismatch of hole momentum prevents a direct elastic, unscattered transmission of holes through

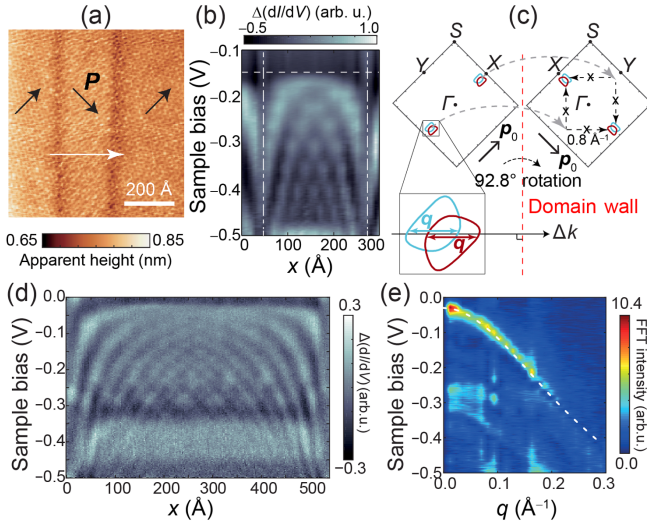


FIG. 10. (a) STM topographic image of  $\sim 90^\circ$  domains on a SnTe ML. (b)  $dI/dV$  spectra acquired along the white arrow in (a) at energies around the VBM. (c) Mismatched hole bands at opposite sides of a  $90^\circ$  domain wall. Constant energy contours with opposite spin components are colored in blue (light gray) and red (dark gray), respectively. (d) Electronic standing wave pattern across a  $540 \text{ \AA}$  wide domain. (e) The Fourier transform of (d) reveals the energy dispersion of scattering vectors. The dashed white curve is the  $E(q)$  dispersion as obtained from the electronic band structure. Adapted from Chang, Miller *et al.*, 2019.

domain walls, giving rise to a peculiar reflection resulting in standing waves (Chang, Miller *et al.*, 2019).

In fact, as depicted in Fig. 10(c), the reflection off a domain wall occurs via a momentum transfer  $\mathbf{q}$  occurring within each hole band. This observation implies that the standing wave pattern is an indirect measure of the electronic band structure around the VBM. From the Fourier transform of the standing wave pattern in Fig. 10(d), a single branch of the energy dispersion with scattering vector  $q$  [inset in Fig. 10(c)] is experimentally resolved in Fig. 10(e) (Chang, Miller *et al.*, 2019); note that  $P(T = 4 \text{ K}) \simeq P_0$ . Although spin-orbit interaction induces band splitting at the VBM, the contribution from the two spin components to the standing wave pattern are identical because of time-reversal symmetry.

## B. Valleytronics

The band curvature  $\hbar^2/m^*$  at the VBM and CBM, where  $m^*$  is the effective mass, is used to estimate the hole and electron conductivities of semiconductors. When determined along orthogonal ( $x$  and  $y$ ) directions, it provides information about the anisotropy of the charge carriers' conductivity. The effective masses at the VBM ( $m^* = m_h$ ) and CBM ( $m^* = m_e$ ) for multiple O-MX MLs (expressed in terms of the electron's mass  $m_0$ ) are listed in Table VIII (Gomes *et al.*, 2016). With the exception of GeS MLs, these effective masses are smaller to those of  $\text{MoS}_2$  [which range within  $-(0.44\text{--}0.48)m_0$  for holes and  $(0.34\text{--}0.38)m_0$  for electrons (Cheiwchanchamnangij and Lambrecht, 2012; Peelaers and Van de Walle, 2012)], implying sharper hole or electron pockets at the VBM or CBM on O-MX MLs than those existing in more traditional materials for

TABLE VIII. Anisotropic effective masses of holes ( $m_h/m_0$ ) and electrons ( $m_e/m_0$ ) at VBM and CBM along the  $x$  and  $y$  directions as shown in Fig. 1(c) for O-MX MLs.

Material	$\bar{Z}$	$(m_h/m_0)_x$	$(m_h/m_0)_y$	$(m_e/m_0)_x$	$(m_e/m_0)_y$
GeS ML	24	-0.26	-0.94	0.24	0.57
GeSe ML	33	-0.17	-0.32	0.17	0.34
GeTe ML	42	-0.15	-0.16	0.08	0.32
SnS ML	33	-0.24	-0.27	0.20	0.22
SnSe ML	42	-0.14	-0.14	0.14	0.14
SnTe ML	51	-0.10	-0.05	0.13	0.14

valleytronic applications (Schaibley *et al.*, 2016). Such a sharpness of the valence (conduction) band curvature permits stating that holes (electrons) belong to a given valley.

Valleytronics refers to the use of the electron or hole pockets at the CBM or VBM as information carriers (Schaibley *et al.*, 2016), which requires creating valley-specific gradients of charge carriers; i.e., a valley polarization. Achieving valley polarization requires the valley degeneracy to be lifted, something that has been demonstrated in TMDC MLs (Rycerz, Tworzydło, and Beenakker, 2007; Xiao *et al.*, 2012). In these 2D materials, valleys at time-reversed states  $+\mathbf{K}$  and  $-\mathbf{K}$  in the BZ couple to the circular polarization of light so that a pseudospin (“up” or “down”) quantum number can be associated with each valley. Valley polarization occurs because right-hand polarized photons excite the carriers only in the  $+\mathbf{K}$  valley, and left-hand polarized photons excite only those in the  $-\mathbf{K}$  valley (Cao *et al.*, 2012; Mak *et al.*, 2012; Sallen *et al.*, 2012; Zeng *et al.*, 2012). When an in-plane electric field is applied across graphene bilayers or TMDC MLs, carriers with up and down pseudospins acquire a transverse velocity in opposite directions because of the opposing Berry curvature in  $+\mathbf{K}$  and  $-\mathbf{K}$  valleys, giving rise to a valley Hall effect (Mak *et al.*, 2014; Shimazaki *et al.*, 2015; Sui *et al.*, 2015).

Unlike a BP ML, which has a single valley centered around the  $\Gamma$  point, the sharp band curvature of the VBM and CBM of O-MX MLs listed in Table VIII permits one to consider them two-valley materials too. They feature a valley along the  $\Gamma$ - $X$  direction (the  $V_x$  valley), and another valley along the  $\Gamma$ - $Y$  direction (the  $V_y$  valley) (Rodin *et al.*, 2016), and valley-selective optical excitation can be realized in these 2D materials using linearly polarized light (Hanakata *et al.*, 2016; Rodin *et al.*, 2016; Shen *et al.*, 2017; Xu *et al.*, 2017).

Figure 11(a) shows valleys located along the  $\Gamma$ - $X$  and  $\Gamma$ - $Y$  lines in the BZ. First-principles calculations and symmetry analysis show that  $x$ -polarized photons have a much higher probability to excite carriers in the  $V_x$  valley. Similarly, carriers in the  $V_y$  valley can be readily excited by  $y$ -polarized light almost exclusively. In other words, a specific valley can be selectively excited by controlling the linear polarization of the incident light [this mechanism does not distinguish among signs: for instance,  $-(\Gamma$ - $X)$  and  $+(\Gamma$ - $X)$  are both the “ $V_x$  valley”]. As an alternative mechanism to produce valley polarization by means of time-reversal symmetry, an in-plane static electric field makes carriers excited from the  $V_x$  valley [located along either the  $-(\Gamma$ - $X)$  or  $+(\Gamma$ - $X)$  line] bend in opposite directions, generating the valley Hall effect



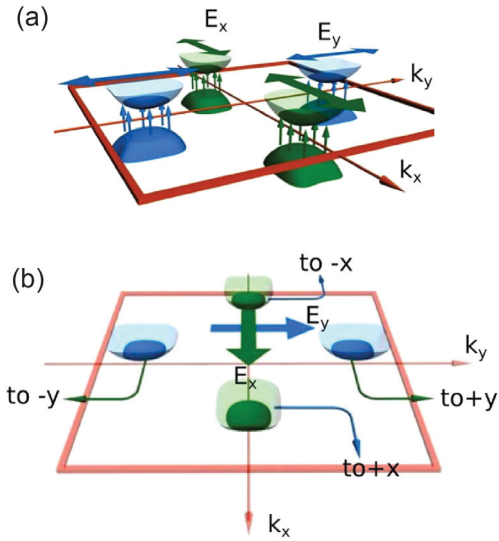


FIG. 11. (a) Valley selection under an external oscillating electric field. Different valleys are excited depending on the field's linear polarization. (b) Valley separation under a static electric field. Depending on the polarization of the field, different valleys flow along perpendicular directions. From Rodin *et al.*, 2016.

illustrated in Fig. 11(b). A similar effect occurs when exciting the  $V_y$  valley. Additional transport effects arising from non-linear electric fields are discussed in Sec. IX.D.

### C. Persistent spin helix behavior

Thus far we have considered the electronic properties of O-MX MLs without concern for spin polarization. Spin-orbit coupling can create various types of spin splitting near the band edges, as well as spin Hall effects in O-MX MLs (Sławińska *et al.*, 2019). Zeeman-like spin splitting is the prominent mechanism in TMDCs (Xiao *et al.*, 2012). On the other hand, a Rashba-like spin-orbit coupling occurs in O-MX MLs due to the spin-orbit field  $\vec{S}_{\text{SOF}}(\mathbf{k}) = \alpha(\hat{\mathbf{P}}_0 \times \mathbf{k})$ , where  $\alpha$  is the spin-orbit coupling strength,  $\hat{\mathbf{P}}_0 = \mathbf{P}_0/P_0$  is the direction of the intrinsic electric polarization in ferroelectrics, and  $\mathbf{k}$  is the quasiparticle electron or hole crystal momentum [Fig. 12(a)].

As indicated in Sec. II, the out-of-plane component of  $\mathbf{P}_0$  is quenched in ultrathin SnTe, making  $\mathbf{P}_0 = P_0\hat{x}$ . Since 2D materials lack crystal momentum along the  $z$  direction,  $\vec{S}_{\text{SOF}}(\mathbf{k}) \propto (\hat{x} \times \mathbf{k})$ , with  $\mathbf{k} = (k_x, k_y, 0)$ . Note that spin

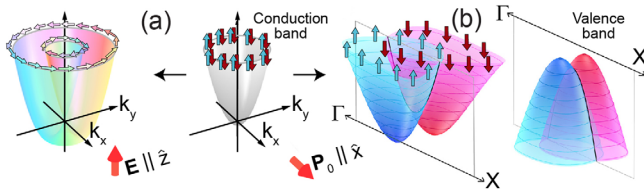


FIG. 12. (a) Conventional and (b) out-of-plane spin Rashba effects at the bottom of the conduction band. In (b), the out-of-plane spin Rashba effect is realized in a SnTe ML, and both the valence and conduction bands are shown. Adapted from Lee, Im, and Jin, 2020.

becomes degenerate along the  $\Gamma$ -X ( $k_y = 0$ ) high-symmetry line, that it points along the  $z$  direction for  $k_y \neq 0$ , and that it reverts direction when either  $k_y$  or  $\mathbf{P}_0$  changes sign (Lee, Im, and Jin, 2020). Rotating  $\mathbf{P}_0$  in the  $y$  direction [see Fig. 6(d)] changes the orientation of the spin-split bands. The strength of the spin-orbit coupling increases with atomic number  $Z$ , as widely reported for O-MX MLs (Shi and Kioupakis, 2015; Rodin *et al.*, 2016; Chang, Miller *et al.*, 2019; Liu, Luo *et al.*, 2019) and other 2D ferroelectrics (Di Sante *et al.*, 2015; Kou *et al.*, 2018; Wang, Xiao *et al.*, 2018; Ai *et al.*, 2019). Recalling that Pb-based MX MLs lack an intrinsic polarization [ $a_{1,0} = a_{2,0}$  in Fig. 1(d) and hence  $\mathbf{P}_0 = 0$ ], the best immediate candidates for 2D ferroelectric Rashba semiconductors within MX MLs are tellurides GeTe and SnTe.

Space group  $P2_1mn$  has the following symmetries (Table IX): (i) the identity  $E$ , (ii)  $\hat{C}_{2x}$ : a twofold rotation around the  $x$  axis ( $C_{2x}$ ) followed by a translation along the diagonal  $\tau = (\mathbf{a}_{1,0} + \mathbf{a}_{2,0})/2$ , (iii) a glide-reflection plane  $\bar{M}_{xy}$ : a reflection by the  $x$ - $y$  plane followed by  $\tau$ , and (iv) a reflection about the  $x$ - $z$  plane ( $M_{xz}$ ) (Rodin *et al.*, 2016). Adding time-reversal symmetry as customarily defined  $\hat{T} = i\sigma_y K$  (where  $K$  represents complex conjugation), the following effective spin Hamiltonian applies at the top of the valence band and at the bottom of the conduction band (Absor and Ishii, 2019; Lee, Im, and Jin, 2020):

$$\hat{H} = \frac{\hbar^2}{2m^*} (k_x^2 + k_y^2) + (\alpha k_y + \alpha' k_x^2 k_y + \alpha'' k_y^3) \sigma_z, \quad (2)$$

with  $m^*$ ,  $\alpha$ ,  $\alpha'$ , and  $\alpha''$  to be fitted from band structure calculations [Fig. 12(b)]. This Hamiltonian does not have contributions from in-plane spin components up to third order in momentum, leading to a persistent spin helix effect with a tunable *out-of-plane spin*. Equation (2) is similar to a Dresselhaus model for a bulk zinc blende crystal oriented along the [110] direction (Dresselhaus, 1955). Estimates of the spin-orbit coupling  $\alpha$  in O-MX's are 2 to 3 orders of magnitude larger than those in III-V semiconductor quantum well structures (Lee, Im, and Jin, 2020), and the wavelength of their spin polarization  $\lambda$  is smaller than that obtained for other Rashba semiconductors (Absor and Ishii, 2019), which permits smaller lateral device dimensions: O-MX MLs furnish an ideal platform for persistent spin helix dynamics (Bernevig, Orenstein, and Zhang, 2006) in two dimensions.

SnTe ML spin transistors may be designed to have a channel length of  $\lambda/4$  so that they can be electrically switched in the ferroelectric channel, or magnetically switched in the ferromagnetic drain (Lee, Im, and Jin, 2020). Another proposal is an all-in-one spin transistor based on the spin

TABLE IX. Transformation rules for  $k_x$ ,  $k_y$ ,  $\sigma_x$ ,  $\sigma_y$ , and  $\sigma_z$  under the symmetry operations of group  $P2_1mn$ , defined as  $\hat{C}_{2x} = i\sigma_x$ ,  $\bar{M}_{xz} = i\sigma_y$ , and  $\bar{M}_{xy} = i\sigma_z$ . Adapted from Absor and Ishii, 2019.

Symmetry operation	$(k_x, k_y)$	$(\sigma_x, \sigma_y, \sigma_z)$
$\hat{E}$	$(k_x, k_y)$	$(\sigma_x, \sigma_y, \sigma_z)$
$\hat{C}_{2x} = i\sigma_x$	$(k_x, -k_y)$	$(\sigma_x, -\sigma_y, -\sigma_z)$
$\bar{M}_{xz} = i\sigma_y$	$(k_x, -k_y)$	$(-\sigma_x, \sigma_y, -\sigma_z)$
$\bar{M}_{xy} = i\sigma_z$	$(k_x, k_y)$	$(-\sigma_x, -\sigma_y, \sigma_z)$
$\hat{T} = i\sigma_y K$	$(-k_x, -k_y)$	$(-\sigma_x, -\sigma_y, -\sigma_z)$

Hall effect, where the inverse spin Hall effect charge current is detuned by an out-of-plane electric field that [according to Fig. 12(a)] breaks the persistent spin helix state down and induces spin decoherence (Sławińska *et al.*, 2019).

## IX. OPTICAL PROPERTIES OF O-MX MLs

### A. Optical absorption

Optical absorption reflects the anisotropy of the electronic band structure of O-MX MLs: linearly polarized light with polarization parallel to the  $x$  direction leads to a smaller absorption energy gap when contrasted with light whose polarization is parallel to the  $y$  axis (Gomes and Carvalho, 2015) (this effect can be observed in Fig. 16, where GW corrections and Bethe-Salpeter electron-hole interactions have been added). The symmetry imposed by the  $P4/nmm$  structural transformation at  $T \geq T_c$  should be reflected on a symmetric optical absorbance (Mehboudi, Fregoso *et al.*, 2016). In addition, according to Shi and Kioupakis (2015) the absorbance of O-MX MLs is unusually strong in the visible range.

### B. Raman spectra

Raman spectroscopy is customarily employed to determine the thickness of layered materials (Li *et al.*, 2012; Castellanos-Gomez *et al.*, 2014). As indicated in Sec. II, the atomic bonds evolve with the number of layers in O-MX MLs (Poudel, Villanova, and Barraza-Lopez, 2019; Ronneberger *et al.*, 2020), which should leave signatures in the Raman spectra. Indeed, Raman modes  $B_{1u}$ ,  $B_{2g}$ ,  $A_g^2$ , and  $B_{3g}^2$  are shown for monolayer and bulk SnS in Fig. 13(a), and a shift as a function of the number of MLs is seen in Fig. 13(b) (Park *et al.*, 2019). Experimentally determined Raman signatures for ultrathin SnS are displayed in Fig. 13(c) for comparison (Higashitarumizu *et al.*, 2020).

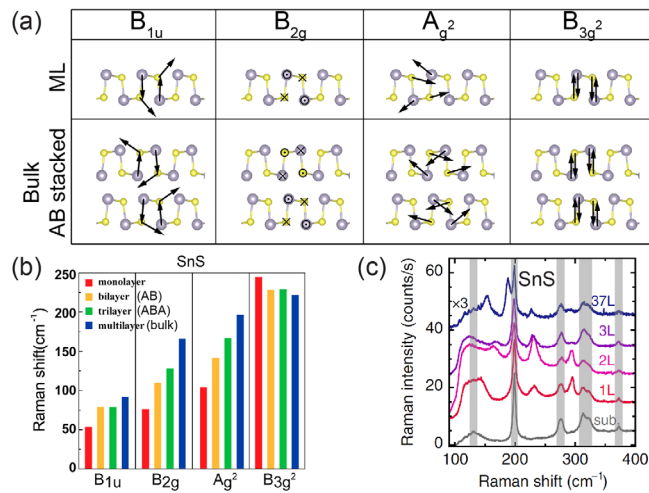


FIG. 13. (a) Relevant phonon modes for Raman spectra of ML and bulk SnS. (b) Raman shift of SnS as a function of MLs. Adapted from Park *et al.*, 2019. (c) Experimentally observed thickness dependence of Raman spectrum at 3 K. The peaks highlighted in gray are due to the substrate. From Higashitarumizu *et al.*, 2020.

### C. Second-harmonic generation

Within a semiclassical picture, the SHG originates from the nonsinusoidal motion of carriers inside crystals lacking inversion symmetry, leading to a quadratic effect in the electric field in O-MX MLs that is forbidden in the bulk. SHG is widely utilized in applications ranging from tabletop frequency multipliers, to surface symmetry probes, and to photon entanglement in quantum computing protocols, among others (Boyd, 2020).

If the incoming electric field is homogeneous and monochromatic  $E^a = E_0^a e^{-i\omega t} + \text{c.c.}$ , the second-order polarization of the crystal oscillates at twice the driving frequency

$$P_2^a = \sum_{bc} \chi_2^{abc}(-2\omega; \omega, \omega) E_0^b E_0^c e^{-i2\omega t} + \text{c.c.}, \quad (3)$$

where  $\chi_2^{abc}(-2\omega; \omega, \omega)$  is the SHG response tensor,  $a$  is the Cartesian direction of the created electric field, and  $b$  and  $c$  are the Cartesian directions of the incident electric fields. Far from the source, the irradiated field is given by  $\mathbf{E} \sim d^2 \mathbf{P}_2 / dt^2$  (Jackson, 1998).

SHG has been reported for ultrathin noncentrosymmetric samples of MoS<sub>2</sub> and *h*-BN with odd layer thicknesses (Li *et al.*, 2013). The angular dependence of SHG also reveals the rotational symmetry of the crystal lattice and can therefore be used to determine the orientation of crystallographic axes (Kim *et al.*, 2013; Kumar *et al.*, 2013; Li *et al.*, 2013; Malard *et al.*, 2013; Janisch *et al.*, 2014; Attacalite *et al.*, 2015; Zhou *et al.*, 2015). This effect has been theoretically (Panday and Fregoso, 2017; Wang and Qian, 2017a) and experimentally (Higashitarumizu *et al.*, 2020) studied in O-MX MLs too.

Following the choice of axes in Fig. 1(c), the polar axis (the direction of  $\mathbf{p}_0$ ) lies along the positive  $x$  direction. The point group of O-MX allows only for nonzero  $xzz$ ,  $xyy$ ,  $xxx$ ,  $yyx$ , and  $zxx$  components of  $\chi_2^{abc}$  (components obtained by exchanging the last two indices are identical  $\chi_2^{abc} = \chi_2^{acb}$ ). As exemplified in a SnS ML in Fig. 14(a), the SHG spectrum

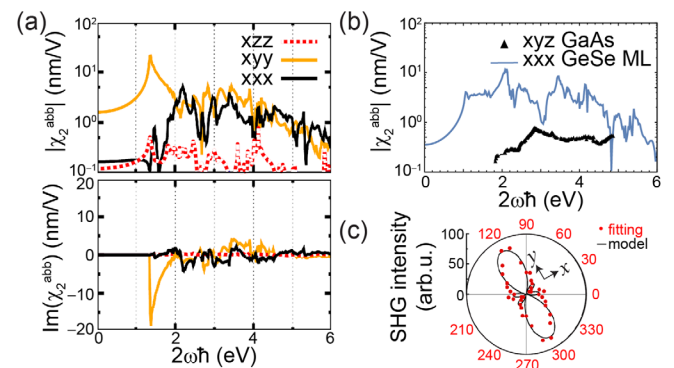


FIG. 14. (a) Absolute and imaginary SHG tensor  $\chi_2^{abb}(-2\omega, \omega, \omega)$  for a SnS ML as a function of the outgoing photon frequency  $2\omega$ . (b) Comparison between the experimental SHG tensor for GaAs(001) from Bergfeld and Daum (2003) and the computed one for a GeSe ML, which is an order of magnitude larger. Adapted from Panday and Fregoso, 2017. (c) Experimental polarization dependence of SHG at 425 nm and room temperature for a SnS ML under perpendicular polarization. The inset axes show the  $x$  and  $y$  directions corresponding to those defined in Fig. 1(c). From Higashitarumizu *et al.*, 2020.

displays peak values within the visible spectrum that can be an order of magnitude larger than those reported for bulk GaAs (Bergfeld and Daum, 2003) [Fig. 14(b)] or for a MoS<sub>2</sub> ML (Malard *et al.*, 2013; Wang and Qian, 2017a). The SHG spectrum is anisotropic, and  $|\chi^{xyy}| > |\chi^{xxx}| > |\chi^{xzz}|$  holds approximately true for all frequencies (Panday and Fregoso, 2017). This is a counterintuitive result, as the maximum response for most frequencies (xyy) occurs for incident optical fields that are perpendicular to the polar axis.

The role of the spontaneous polarization  $\mathbf{P}_0$  in the large SHG response tensor and in other nonlinear responses is an active area of investigation. The large magnitude of the SHG in O-MX MLs seems to be a combination of many factors, including their reduced dimensionality and in-plane polarization. Indirect evidence suggests that the in-plane  $\mathbf{P}_0$  enhances the SHG by establishing mirror symmetries that strongly constrain contributions from certain regions within the BZ (Panday *et al.*, 2019).

O-MX MLs grown on insulating substrates permit one to perform optical experiments, and Fig. 14(c) is an experimental demonstration of the anisotropic behavior of the SHG of a SnS ML (Wang and Qian, 2017a) at room temperature, using an 850 nm laser as the excitation source (Higashitarumizu *et al.*, 2020). The largest SHG occurs along the  $y$  axis. As discussed in Sec. IV, the sense of direction of  $\mathbf{P}$  can be set by a combination of SHG and transport measurements.

#### D. Bulk photovoltaic effects: Injection and shift currents

The bulk photovoltaic effect (BPVE) is the generation of a dc current upon illumination in materials that lack inversion symmetry. It has been extensively studied in bulk ferroelectrics (Sturman and Fridkin, 1992; Ivchenko and Ganichev, 2016), topological insulators (Hosur, 2011), 2D ferroelectrics (Kushnir *et al.*, 2017, 2019; Rangel *et al.*, 2017; Panday *et al.*, 2019), Weyl semimetals (Chan *et al.*, 2017; de Juan *et al.*, 2017; Rees *et al.*, 2019; Shvetsov *et al.*, 2019), and BN nanotubes (Král, Mele, and Tománek, 2000), among other materials. Many seemingly unrelated BPVEs have been shown to have a common origin (Sipe and Shkrebtii, 2000; Fregoso, 2019). The BPVE is much larger in 2D ferroelectrics than in bulk ferroelectrics, potentially overcoming the low solar energy efficiency conversion found in the latter (Spanier *et al.*, 2016; Tan *et al.*, 2016; Rappe, Grinberg, and Spanier, 2017).

The BPVE differs from other photovoltaic effects in three important ways: (i) it is proportional to the intensity of the optical field; (ii) it produces large open-circuit photovoltages, i.e., larger than the energy band gap; and (iii) it depends on the polarization state of the light. These characteristics imply, respectively, (i) that the BPVE is a second-order effect in the optical field, (ii) that it is an ultrafast phenomena occurring before thermalization takes place at the CBM (VBM), and (iii) that the BPVE response tensor has a real and an imaginary component. The real component ( $\sigma_2$ ) determines the response to linearly polarized light; the imaginary component ( $\eta_2$ ) is the response to circularly polarized light. Denoting a homogeneous optical field by  $\mathbf{E}$ , the BPVE can then be schematically written as (Sturman and Fridkin, 1992)

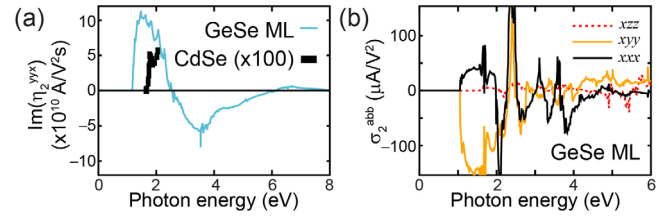


FIG. 15. (a) Injection current and (b) shift current for a GeSe ML [with Cartesian axes defined as in Fig. 1(c)]. The injection current of CdSe is also plotted for comparison. Adapted from Rangel *et al.*, 2017 and Panday *et al.*, 2019.

$$\mathbf{J}_{\text{BPVE}} = \eta_2 \mathbf{E} \times \mathbf{E}^* + \sigma_2 \mathbf{E}^2. \quad (4)$$

The first term is the so-called ballistic current, injection current, or circular photogalvanic effect, and it vanishes for linear polarization. The injection current is created by an unequal momentum relaxation into time-reversed states (Sturman and Fridkin, 1992; Ivchenko and Ganichev, 2016) or by unequal carrier pumping rates into time-reversed states  $\pm \mathbf{k}$  (Sipe and Shkrebtii, 2000; Fregoso, 2019). In addition, and related to the spin effects discussed in Sec. VIII.C, the chirality of circularly polarized light couples to the spin of charge carriers to generate a spin current in spin-orbit coupled systems (Sturman and Fridkin, 1992; Hosur, 2011; Chan *et al.*, 2017). Figure 15(a) shows the spectrum of the injection current tensor for a GeSe ML. The only nonzero component is  $\eta_2^{yyx}$  and, as a consequence, injection current can flow only perpendicularly to the polar ( $x$ ) axis. The injection current tensor  $\eta_2$  reaches peak values of  $10^{11}$  A/V<sup>2</sup> s in the visible spectrum (1.5–3 eV) (Panday *et al.*, 2019; Wang and Qian, 2019), which is many orders of magnitude larger than its peak value in MoS<sub>2</sub> MLs (Arzate *et al.*, 2016).

The second term in Eq. (4) is the *shift* current, also known as the *linear photogalvanic effect*, and its microscopic interpretation is still under debate. A popular interpretation is that the shift current arises from a shift of the electron in real space when it absorbs a photon (von Baltz and Kraut, 1981). This is reasonable since the Wannier centers of charge are spatially separated in materials that break inversion symmetry. In a second interpretation, the quantum coherent motion of a pair of dipoles moving in  $k$  space originates shift currents (Fregoso, 2019), which vanish for incident circularly polarized light. Figure 15(b) shows the shift-current spectra for a GeSe ML. There is a broad maximum of the order of 150  $\mu\text{A}/\text{V}^2$  (Rangel *et al.*, 2017) in the visible range (1–3 eV) that is larger than its magnitude in prototypical materials [ $\sigma_2 \sim 0.1 \mu\text{A}/\text{V}^2$  in BiFeO<sub>3</sub> (Young and Rappe, 2012)]. These results demonstrate the unique potential of O-MX MLs for optoelectronic applications.

#### E. Photostriction

Photostriction is the structural change induced by a screened electric polarization  $\mathbf{P}$  resulting from photoexcited electronic states: optical excitations will lead to a concurrent compression of lattice vector  $\mathbf{a}_1$  and a comparatively smaller increase of  $\mathbf{a}_2$  for an overall reduction in the unit cell area. The structural change documented for SnS and SnSe MLs is 10



times larger than that observed in bulk ferroelectric BiFeO<sub>3</sub>, making O-MX MLs an ultimate platform for this effect (Haleoot *et al.*, 2017).

## F. Excitons

An exciton is an electron-hole pair hosted within a material, whose description therefore goes beyond the single-particle picture employed thus far. Excitons display a strong dependency on dimensionality, being more strongly bound in low-dimensional systems due to a reduced Coulomb screening and hence relevant for applications at room temperature (Gomes *et al.*, 2016). Upon laser irradiation, a MoS<sub>2</sub> ML displays isotropic excitons with a binding energy of 0.55 eV on a graphitic substrate (Splendiani *et al.*, 2010; Ugeda *et al.*, 2014). In turn, anisotropic excitons in BP MLs have been shown to have a larger binding energy of 0.8–0.9 eV (Rodin, Carvalho, and Castro Neto, 2014a; Tran *et al.*, 2014; Wang *et al.*, 2015). Possible optoelectronic applications of O-MX MLs also call for a deep understanding of excitons (Gomes *et al.*, 2016). Given that they contribute to the dielectric environment, substrates in which 2D materials are placed may need to be accounted for when comparing experiment and theory.

The exciton binding energy has been calculated for free-standing GeS, GeSe, and SnSe MLs. It increases from less than 0.01 eV in the bulk to 1.00 eV on a GeS ML, 0.32–0.40 eV on a GeSe ML, and 0.27–0.30 eV in a SnSe ML. As seen in Fig. 16(a), the binding energy is larger in materials with small  $\bar{Z}$ , for which the absorbance is more anisotropic when shining light with polarization along the  $x$  or  $y$  directions (Shi and Kioupakis, 2015; Gomes *et al.*, 2016). Concomitant with a stronger binding and anisotropic absorbance, lighter O-MX MLs host more localized and anisotropic excitons; see Fig. 16(b). An analytical Mott-Wannier model was employed to account for the effect of the supporting

substrate (which in general lowers the exciton binding energy) by Gomes *et al.* (2016).

## X. SUMMARY AND OUTLOOK

Two-dimensional and ultrathin multiferroics are gaining increasing attention. They complement two-dimensional semimetal graphene, insulator hexagonal boron nitride, a large number of 2D semiconductors, and two-dimensional magnets. This Colloquium describes the structural, mechanical, electronic, and optical properties of group-IV monochalcogenide MLs in a comprehensive manner, including recent developments such as the experimental realization of SnS and SnSe MLs, and novel theoretical results such as spin helix behavior, theoretical Raman spectra, and bulk photovoltaic effects, to become the most up-to-date reference on these materials. While there are a number of challenges still to be resolved concerning chemical stability, exfoliation or growth, and their stacking into functional layered materials, these ultrathin ferroelectric and ferroelastic materials have already diversified and enriched the library of layered and two-dimensional functional materials. Their prospective use in memory, valley, and optoelectronic applications can provide the motivation and justification to drive further progress in this area.

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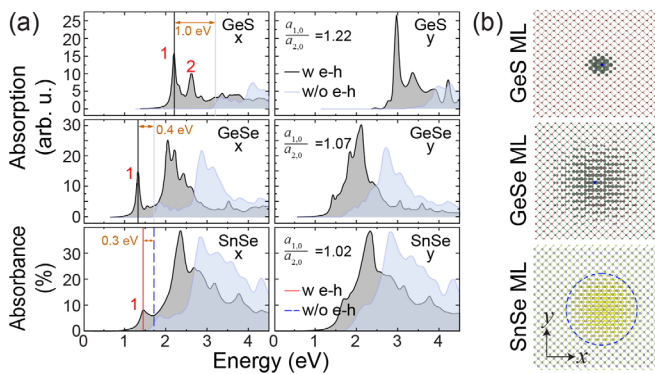


FIG. 16. (a) Absorption spectra of GeS, GeSe, and SnSe MLs with (w  $e-h$ ) and without (w/o  $e-h$ ) electron-hole interactions for light polarized along the  $x$  direction (i.e., parallel to  $\mathbf{P}_0$ ) or along the  $y$  direction (perpendicular to  $\mathbf{P}_0$ ). Two peaks are identified for GeS MLs: peak 1 arises from a direct transition at the  $\Gamma$  point, and peak 2 arises from a direct transition at the  $V_x$  valley; see Fig. 9. For both GeSe and SnSe MLs, the only excitation within the band gap corresponds to a direct transition at the  $V_x$  valley. (b) GeS, GeSe, and SnSe MLs. Adapted from Shi and Kioupakis, 2015 and Gomes *et al.*, 2016.

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